

ES29LV320D

32Mbit(4M x 8/2M x 16) CMOS 3.0 Volt-only, Boot Sector Flash Memory - Preliminary Draft -

GENERAL FEATURES

- · Single power supply operation
 - 2.7V -3.6V for read, program and erase operations
- Sector Structure
 - 8Kbyte x 8 boot sectors
 - 64Kbyte x 63 sectors
 - 256byte security sector
- Top or Bottom boot block
 - ES29LV320DT for Top boot block device
 - ES29LV320DB for Bottom boot block device
- · A 256 bytes of extra sector for security code
 - Factory lockable
 - Customer lockable
- Package Options
 - 48-pin TSOP
 - 48-ball FBGA (8 x 9 mm)
 - Pb-free packages
- · Low Vcc write inhibit
- Manufactured on 0.18um process technology
- · Compatible with JEDEC standards
 - Pinout and software compatible with single-power supply flash standard

DEVICE PERFORMANCE

- · Read access time
 - 90ns/120n for normal Vcc range (2.7V 3.6V)
 - 80ns for regulated Vcc range (3.0V 3.6V)
- · Program and erase time
 - Program time : 9us/byte, 11us/word (typical)
 - Accelerated program time: 8us/word (typical)
 - Sector erase time: 0.7sec/sector (typical)
- · Power consumption (typical values)
 - 200nA in standby or automatic sleep mode
 - 10 mA active read current at 5 MHz
 - 15mA active write current during program or erase

- Minimum 100,000 program/erase cycles per sector
- 20 Year data retention at 125°C

SOFTWARE FEATURES

- Erase Suspend / Erase Resume
- Data# poll and toggle for Program/erase status
- · CFI (Common Flash Interface) supported
- Unlock Bypass program
- Autoselect mode
- Auto-sleep mode after t_{ACC} + 30ns

HARDWARE FEATURES

- Hardware reset input pin (RESET#)
 - Provides a hardware reset to device
 - Any internal device operation is terminated and the device returns to read mode by the reset
- Ready/Busy# output pin (RY/BY#)
 - Provides a program or erase operational status about whether it is finished for read or still being progressed
- WP#/ACC input pin
 - Two outermost boot sectors are protected when WP# is set to low, regardless of sector protection
 - Program speed is accelerated by raising WP#/ACC to a high voltage (12V)
- Sector protection / unprotection (RESET# , A9)
 - Hardware method of locking a sector to prevent any program or erase operation within that sector
 - Two methods are provided :
 - In-system method by RESET# pin
 - A9 high-voltage method for PROM programmers
- Temporary Sector Unprotection (RESET#)
- Allows temporary unprotection of previously protected sectors to change data in-system



GENERAL PRODUCT DESCRIPTION

The ES29LV320 is a 32 megabit, 3.0 volt-only flash memory device, organized as 4M x 8 bits (Byte mode) or 2M x 16 bits (Word mode) which is configurable by BYTE#. Eight boot sectors and sixty three main sectors with uniform size are provided: 8Kbytes x 8 and 64Kbytes x 63. The device is manufactured with ESI's proprietary, high performance and highly reliable 0.18um CMOS flash technology. The device can be programmed or erased in-system with standard 3.0 Volt Vcc supply (2.7V-3.6V) and can also be programmed in standard EPROM programmers. The device offers minimum endurance of 100,000 program/erase cycles and more than 10 years of data retention.

The ES29LV320 offers access time as fast as 80ns or 90ns, allowing operation of high-speed microprocessors without wait states. Three separate control pins are provided to eliminate bus contention: chip enable (CE#), write enable (WE#) and output enable (OE#).

All program and erase operation are automatically and internally performed and controlled by embedded program/erase algorithms built in the device. The device automatically generates and times the necessary high-voltage pulses to be applied to the cells, performs the verification, and counts the number of sequences. Some status bits (DQ7, DQ6 and DQ5) read by data# polling or toggling between consecutive read cycles provide to the users the internal status of program/erase operation: whether it is successfully done or still being progressed.

Extra Security Sector of 256 bytes

In the device, an extra security sector of 256 bytes is provided to customers. This extra sector can be used for various purposes such as storing ESN (Electronic Serial Number) or customer's security codes. Once after the extra sector is written, it can be permanently locked by the device manufacturer(factory-locked) or a customer(customer-lockable). At the same time, a lock indicator bit (DQ7) is permanently set to a 1 if the part is factory-locked. or set to 0 if it is customer-lockable. Therefore, this lock indicator bit (DQ7) can be properly used to avoid that any customer-lockable part is used to replace a factory-locked part. The extra security sector is an extra memory space for customers when it is used as a customer-lockable version. So. it can be read and written like any other sectors. But it should be noted that the number of E/W(Erase and Write) cycles is limited to 300 times (maximum) only in the Security Sector.

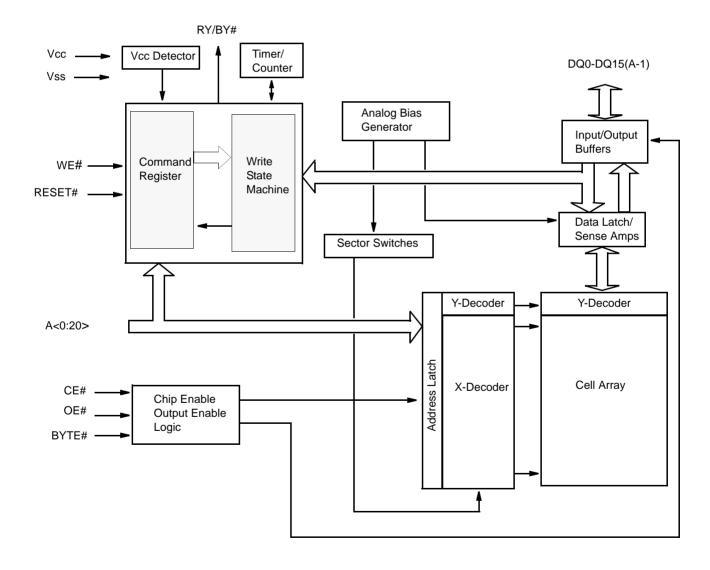
Special services such as ESN and factory-lock are available to customers (ESI's **Special-Code service**) The ES29LV320 is completely compatible with the JEDEC standard command set of single power supply Flash. Commands are written to the internal command register using standard write timings of microprocessor and data can be read out from the cell array in the device with the same way as used in other EPROM or flash devices.



PRODUCT SELECTOR GUIDE

| Family Part Number | ES29LV320 | | | | | |
|----------------------|-----------------------|----|-----|--|--|--|
| Voltage Range | 3.0 ~ 3.6V 2.7 ~ 3.6V | | | | | |
| Speed Option | 80R | 90 | 120 | | | |
| Max Access Time (ns) | 80 | 90 | 120 | | | |
| CE# Access (ns) | 80 | 90 | 120 | | | |
| OE# Access (ns) | 35 | 40 | 50 | | | |

FUNCTION BLOCK DIAGRAM

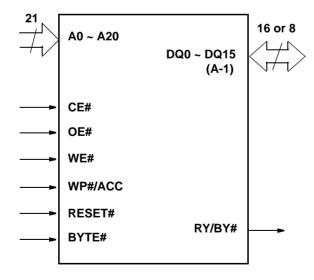




PIN DESCRIPTION

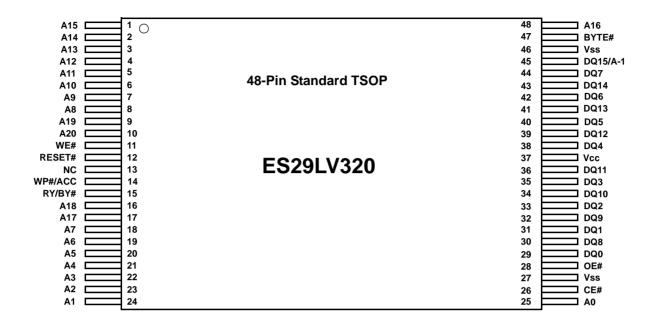
| Pin | Description |
|----------|----------------------------------------------------------------------------------------------------------------|
| A0-A20 | 21 Addresses |
| DQ0-DQ14 | 15 Data Inputs/Outputs |
| DQ15/A-1 | DQ15 (Data Input/Output, Word Mode) A-1 (LSB Address Input, Byte Mode) |
| CE# | Chip Enable |
| OE# | Output Enable |
| WE# | Write Enable |
| WP#/ACC | Hardware Write Protect/Acceleration Pin |
| RESET# | Hardware Reset Pin, Active Low |
| BYTE# | Selects 8-bit or 16-bit mode |
| RY/BY# | Ready/Busy Output |
| Vcc | 3.0 volt-only single power supply (see Product Selector Guide for speed options and voltage supply tolerances) |
| Vss | Device Ground |
| NC | Pin Not Connected Internally |

LOGIC SYMBOL



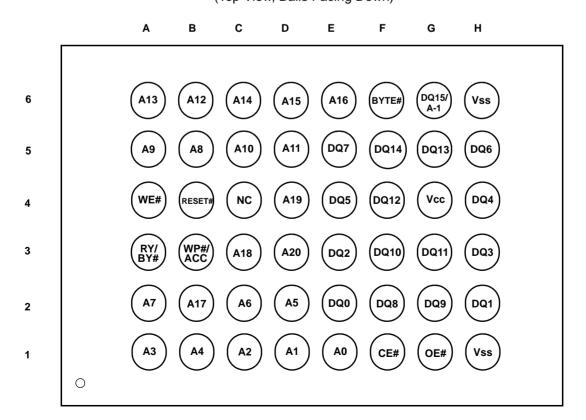


CONNECTION DIAGRAM



48-Ball FBGA (8 x 9 mm)

(Top View, Balls Facing Down)





DEVICE BUS OPERATIONS

Several device operational modes are provided in the ES29LV320 device. Commands are used to initiate the device operations. They are latched and stored into internal registers with the address and data information needed to execute the device operation.

The available device operational modes are listed in Table 1 with the required inputs, controls, and the resulting outputs. Each operational mode is described in further detail in the following subsections.

Read

The internal state of the device is set for the read mode and the device is ready for reading array data upon device power-up, or after a hardware reset. To read the stored data from the cell array of the device, CE# and OE# pins should be driven to V_{IL} while WE# pin remains at V_{IH} . CE# is the power control and selects the device. OE# is the output control and gates array data to the output pins.

Word or byte mode of output data is determined by the BYTE# pin. No additional command is needed in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device stays at the read mode until another operation is activated by writing commands into the internal command register. Refer to the AC read cycle timing diagrams for further details (Fig. 18).

Word/Byte Mode Configuration (BYTE#)

The device data output can be configured by BYTE# into one of two modes: word and byte modes. If the BYTE# pin is set at logic '1', the device is configured in word mode, DQ0 - DQ15 are active and controlled by CE# and OE#. If the BYTE# pin is set at logic '0', the device is configured in byte mode, and only data I/O pins DQ0 - DQ7 are active and controlled by CE# and OE#. The data I/O pins DQ8 - DQ14 are tristated, and the DQ15 pin is used as an input for the LSB (A-1) address.

Standby Mode

When the device is not selected or activated in a system, it needs to stay at the standby mode, in which current consumption is greatly reduced with outputs in the high impedance state.





The device enters the CMOS standby mode when CE# and RESET# pins are both held at Vcc+0.3V. (Note that this is a more restricted voltage range than VIH) If CE# and RESET# are held at VIH, but not within Vcc±0.3V, the device will be still in the standby mode, but the standby current will be greater than the CMOS standby current (0.2uA typically). When the device is in the standby mode, only standard access time (t_{CF}) is required for read access, before it is ready for read data. And even if the device is deselected by CE# pin during erase or programming operation, the device draws active current until the operation is completely done. While the device stays in the standby mode, the output is placed in the high impedance state, independent of the OE# input.

The device can enter the deep power-down mode where current consumption is greatly reduced down to less than 0.2uA typically by the following three ways:

- CMOS standby (CE#, RESET# = $Vcc \pm 0.3V$)
- During the device reset (RESET# = Vss $\pm 0.3V$)
- In Autosleep Mode (after t_{ACC} + 30ns)

Refer to the CMOS DC characteristics Table11 for further current specification.

Autosleep Mode

The device automatically enters a deep power-down mode called the autosleep mode when addresses remain stable for t_{ACC} +30ns. In this mode, current consumption is greatly reduced (less than 0.2uA typical), regardless of CE#, WE# and OE# control signals.

Writing Commands

To write a command or command sequences to initiate some operations such as program or erase, the system must drive WE# and CE# to V_{IL} , and OE# to V_{IH} . For program operations, the BYTE# pin determines whether the device accepts program data in bytes or words. Refer to "BYTE# timings for Write Operations" in the Fig. 21 for more information.

Unlock Bypass Mode

To reduce more the programming time, an unlockbypass mode is provided. Once the device enters this mode, only two write cycles are required to initiate the programming operation instead of four cycles in the normal program command sequences which are composed of two unlock cycles, program set-up cycle and the last cycle with the program data and addresses. In this mode, two unlock cycles are saved (or bypassed).

Sector Addresses

The entire memory space of cell array is divided into a many of small sectors: 8kbytes x 8 boot sectors and 64Kbytes x 63 main sectors. In erase operation, a single sector, multiple sectors, or the entire device (chip erase) can be selected for erase. The address space that each sector occupies is shown in detail in the Table 3-4.

Accelerated Program Mode

The device offers accelerated program operations through the ACC function. This is one of two functions provided by the WP#/ACC pin. This function is primarily intended to allow faster manufacturing throughput at the factory. If the system asserts V_{HH} (11.5~12.5V) on this pin, the device automatically enters the previously mentioned Unlock Bypass mode, temporarily unprotects any protected sectors, and uses the higher voltage on the pin to reduce the time required for program operations. Only two-cycle program command sequences are required because the unlock bypass mode is automatically activated in this acceleration mode. The device returns to the normal operation when V_{HH} is removed from the WP#/ACC pin. It should be noted that the WP#/ACC pin must not be at V_{HH} for operations other than accelerated programming, or device damage may result. In addition, the WP#/ ACC pin must not be left floating or unconnected; inconsistent or undesired behavior of the device may result.

Autoselect Mode

Flash memories are intended for use in applications where the local CPU alters memory contents. In such applications, manufacturer and device identification (ID) codes must be accessible while the device resides in the target system (the so called "in-system program"). On the other hand, signature codes have been typically accessed by raising A9 pin to a high voltage in PROM programmers. However, multiplexing high voltage onto address lines is not the generally desired system design practice. Therefore, in the ES29LV320 device an autoselect command is provided to allow the system to access the signature codes without any high voltage. The conventional A9 high-voltage method used in the PROM programers for signature codes are still supported in this device.



If the system writes the autoselect command sequence, the device enters the Autoselect mode. The system can then read some useful codes such as manufacturer and device ID from the internal registers on DQ7 - DQ0. Standard read cycle timings apply in this mode. In the Autoselect mode, the following four informations can be accessed through either autoselect command method or A9 high-voltage autoselect method. Refer to the Table 2.

- Manufacturer ID
- Device ID
- Security Sector Lock-indicator
- Sector protection verify

Hardware Device Reset (RESET#)

The RESET# pin provides a hardware method of resetting the device to read array data. When the RESET# pin is driven low for at least a period of t_{RP} , the device immediately terminates any operation in progress, tristates all output pins, and ignores all read/write commands for the duration of the RESET# pulse The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once after the device is ready to accept another command sequence, to ensure data integrity.

CMOS Standby during Device Reset

Current is reduced for the duration of the RESET# pulse. When RESET# is held at Vss \pm 0.3V, the device draws the greatly reduced CMOS standby current (I_{CC4}). If RESET# is held at V_{IL} but not within Vss+0.3V, the standby current will be greater.

RY/BY# and Terminating Operations

If RESET# is asserted during a program or erase operation, the RY/BY# pin remains a "0" (busy) until the internal reset operation is completed, which requires a time of t_{READY} (during Embedded Algorithms). The system can thus monitor RY/BY# to determine whether the reset operation is completed. If RESET# is asserted when a program or erase operation is not executing (RY/BY# pin is "1"), the reset operation is completed within a time of t_{READY} (not during Embedded Algorithms). The system can read data after the RESET# pin returns to V_{IH} , which requires a time of t_{RH}

RESET# tied to the System Reset

The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the

Flash memory, enabling the system to read the boot-up firmware from the Flash memory. Refer to the AC Characteristics tables for RESET# parameters and to Fig. 19 for the timing diagram.

SECTOR GROUP PROTECTION

The ES29LV320 features hardware sector group protection. A sector group consists of two or more adjacent sectors that are protected or unprotected at the same time. In the device, sector protection is performed on the group of sectors previously defined in the Table 3-4. Once after a group of sectors are protected, any program or erase operation is not allowed in the protected sector group. The previously protected sectors must be unprotected by one of the unprotect methods provided here before changing data in those sectors. Sector protection can be implemented via two methods.

- In-system protection
- A9 High-voltage protection

To check whether the sector group protection was successfully executed or not, another operation called "**protect verification**" needs to be performed after the protection operation on a group of sectors. All protection and protect verifications provided in the device are summarized in detail at the Table 1.

In-System Protection

"In-system protection", the primary method, requires V_{ID} (11.5V~12.5V) on the **RESET#** with A6=0, A1=1, and A0=0. This method can be implemented either in-system or via programming equipment. This method uses standard microprocessor bus cycle timing. Refer to Fig. 29 for timing diagram and Fig. 3 for the protection algorithm.

A9 High-Voltage Protection

"High-voltage protection", the alternate method intended only for programming equipment, must force V_{ID} (11.5~12.5V) on address pin **A9** and control pin **OE#** with A6=0, A1=1 and A0=0. Refer to Fig. 31 for timing diagram and Fig. 5 for the protection algorithm.

SECTOR UNPROTECTION

The previously protected sectors must be unprotected before modifying any data in the sectors. The sector unprotection algorithm unprotects all sectors in parallel. All unprotected sectors must first



be protected prior to the first sector unprotection write cycle to avoid any over-erase due to the intrinsic erase characteristics of the protection cell. After the unprotection operation, all previously protected sectors will need to be individually re-protected. Standard microprocessor bus cycle timings are used in the unprotection and unprotect verification operations. Three unprotect methods are provided in the ES29LV320 device. All unprotection and unprotect verification cycles are summarized in detail at the Table 1.

- In-system unprotection
- A9 High-voltage unprotection
- Temporary sector unprotection

In-System Unprotection

"In-system unprotection", the primary method, requires V_{ID} (11.5V~12.5V) on the **RESET#** with A6=1, A1=1, and A0=0. This method can be implemented either in-system or via programming equipment. This method uses standard microprocessor bus cycle timing. Refer to Fig. 29 for timing diagram and Fig. 4 for the unprotection algorithm.

A9 High-Voltage Unprotection

"High-voltage unprotection", the alternate method intended only for programming equipment, must force V_{ID} (11.5~12.5V) on address pin **A9** and control pin **OE#** with A6=1, A1=1 and A0=0. Refer to Fig. 32 for timing diagram and Fig. 6 for the unprotection algorithm.

Temporary Sector Unprotect

This feature allows temporary unprotection of previously protected sectors to change data in-system. The Sector Unprotect mode is activated by setting the RESET# pin to V_{ID} (11.5V-12.5V). During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once V_{ID} is removed from the RESET# pin, all the previously protected sectors are protected again. Fig. 1 shows the algorithm, and Fig. 27 shows the timing diagrams for this feature.

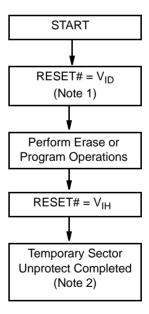
WRITE PROTECT (WP#)

The Write Protect function provides a hardware method of protecting certain boot sectors without using V_{ID} . This function is one of two provided by the WP#/ACC pin.

If the system asserts $V_{\rm IL}$ on the WP#/ACC pin, the device disables program and erase functions in the **two "outermost" 8Kbytes boot sectors** independently of whether those sectors were protected or unprotected using the method described in "Sector Group Protection and Unprotection". The two outermost of 8 Kbyte boot sectors are the two sectors containing the lowest addresses in a bottom-bootconfigured device, or the two sectors containing the highest addresses in a top-boot-configured device.

If the system asserts V_{IH} on the WP#/ACC pin, the device reverts to whether the two outermost 8 Kbyte boot sectors were last set to be protected or unprotected. That is, sector protection or unprotection for these two sectors depends on whether they were last protected or unprotected using the method described in "Sector Group Protection and Unprotection".

Note that the WP#/ACC pin must not be left floating or unconnected; inconsistent behavior of the device may result.



Notes:

- All protected sectors are unprotected (If WP#/ACC = V_{IL}, outermost boot sectors will remain protected).
- 2. All previously protected sectors are protected once again.

Figure 1. Temporary Sector Unprotect Operation



SECURITY SECTOR

The security sector of the ES29LV320 device provides an extra flash memory space that enables permanent part identification through an Electronic Serial Number (ESN). The security sector uses a **security lock-Indicator Bit (DQ7)** to indicate whether or not the security sector is locked when shipped from the factory. This bit is permanently set at the factory and cannot be changed, which prevents cloning of a factory locked part. This ensures the security of the ESN once the product is shipped to the field. Note that the ES29LV320 has a security sector size of **256 bytes**.

Security Lock-Indicator Bit (DQ7)

In the device, the security sector can be provided in either factory locked version or customer lockable version. The **factory-locked version** is always protected when shipped from the factory, and has the security lock-Indicator Bit permanently set to a "1". The **customer-lockable version** is shipped with the security sector unprotected, allowing customers to utilize the sector in any manner they choose. The customer-lockable version has the security lock-Indicator Bit permanently set to a "0". Thus, the security lock-Indicator Bit prevents customer-lockable devices from being used to replace devices that are factory locked.

Access to the Security Sector

The security sector can be accessed through a command sequence: Enter security and Exit security sector commands. After the system has written the Enter security sector command sequence, it may read the security sector by using the addresses normally occupied by the boot sectors. This mode of operation continues until the system issues the Exit security sector command sequence, or until power is removed from the device. On power-up, or following a hardware reset, the device returns to read mode in which the normal boot sectors can be accessed, instead of the security sector.

Factory-Locked Device

In a factory-locked device, the security sector is protected when the device is shipped from the factory. The security sector cannot be modified in any way. The device is available preprogrammed with one of the following:

- A random, secure ESN (16 bytes) only
- Customer code through the ESI's Special-Code service
- Both a random, secure ESN and customer code through the ESI's Special-Code service.

ESN (Electronic Serial Number)

In devices that have an ESN, a Bottom Boot device will have the 16-byte (8-word) ESN in sector 0 at addresses 000000h-00000Fh in byte mode (or 000000h-000007h in word mode). In the Top Boot device the ESN will be in sector 70 at addresses 3FFF00h-3FFF0Fh in byte mode (or 1FFF80h-1FF87h in word mode). Note that in upcoming top boot versions of this device, the ESN will be located in sector 70 at addresses 3FFF00h-3FFF0Fh in byte mode (or 1FFF80h-1FFF87h in word mode).

ESI's Special-Code Service

Customers may opt to have their code programmed by ESI through the ESI's Special-Code service. ESI programs the customer's code, with or without the random ESN. The devices are then shipped from ESI's factory with the Security Sector permanently locked. Contact an ESI representative for details on using ESI's Special-Code service.

Customer-Lockable Device

The customer lockable version allows the security sector to be freely programmed or erased and then permanently locked. Note that the ES29LV320 has a security sector size of 256 bytes (128 words). Note that the accelerated programming (ACC) and unlock bypass functions are not available when programming the security sector.

Protection of the Security Sector

The security sector area can be protected using the following procedures: Write the three-cycle "Enter security sector command" sequence, and then following the in-system sector protect algorithm as shown in Fig. 2, except that RESET# may be at either V_{IH} or V_{ID} . This allows in-system protection of the security sector without raising any device pin to a high voltage. Note that this method is only applicable to the security sector. To verify the protect/unprotect status of the security sector. follow the algorithm shown in Fig. 2.

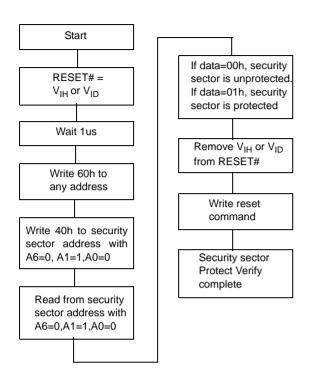


Figure 2. Security Sector Protect Verify

Exit from the Security Sector

Once the Security Sector is locked protected and verified, the system must write the Exit Security Sector Region command sequence to return to reading and writing the remainder of the array.

Caution for the Security Sector Protection

The security sector protection must be used with caution since, once protected, there is no procedure available for unprotecting the security sector area and none of the bits in the security sector memory space can be modified in any way.

HARDWARE DATA PROTECTION

The ES29LV320 device provides some protection measures against accidental erasure or programming caused by spurious system level signals that may exist during power transition. During powerup, all internal registers and latches in the device are cleared and the device automatically resets to the read mode. In addition, with its internal state machine built-in the device, any alteration of the memory contents or any initiation of new operation

can only occur after successful completion of specific command sequences. And several features are incorporated to prevent inadvertent write cycles resulting from Vcc power-up and power-down transition or system noise.

Low Vcc Write inhibit

When Vcc is less than V_{LKO} , the device does not accept any write cycles. This protects data during Vcc power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets to the read mode. Subsequent writes are ignored until Vcc is greater than V_{LKO} . The system must provide proper signals to the control pins to prevent unintentional writes when Vcc is greater than V_{LKO} .

Write Pulse "Glitch" Protection

Noise pulses of less than 5ns (typical) on OE#, CE# or WE# do not initiate a write cycle.

Logical inhibit

Write cycles are inhibited by holding any one of $OE\#=V_{IL}$, $CE\#=V_{IH}$ or $WE\#=V_{IH}$. To initiate a write cycle, CE# and WE# must be a logical zero while OE# is a logical one.

Power-up Write Inhibit

If WE#=CE#= V_{IL} and OE#= V_{IH} during power up, the device does not accept any commands on the rising edge of WE#. The internal state machine is automatically reset to the read mode on power-up.



Table 1. ES29LV320 Device Bus Operations

| | | | | | | | | DQ0 | ı | DQ8~DQ15 | |
|-----------------------------|----------------------------------------------|----------------------|-----------------|-----------------------|----------------------|----------------------------|-----------------------------------------------|------------------|------------------|----------------------------------|--|
| Ор | Operation CE# OE# WE# RESET# WP#/A | | WP#/ACC | Addresses (Note 1) | DQ7 | BYTE# = V _{IH} | BYTE# = V _{IL} | | | | |
| Read | | L | L | Н | Н | L/H | A _{IN} | D _{OUT} | D _{OUT} | DO0 DO44 15-b 7 | |
| Write | | L | Н | L | Н | (Note 3) | A _{IN} | (Note 4) | (Note 4) | DQ8~DQ14 = High-Z, DQ15 = A-1 | |
| Accelerated P | rogram | L | Н | L | Н | V_{HH} | A _{IN} | (Note 4) | (Note 4) | | |
| Standby | | Vcc <u>+</u> 0.3V | х | х | Vcc <u>+</u> 0.3V | Н | Х | High-Z | High-Z | | |
| Output Disable | е | L | Н | Н | Н | L/H | Х | High-Z | High-Z | High-Z | |
| Reset | | Х | Х | Х | L | L/H | Х | High-Z | High-Z | | |
| | Sector Protect (Note 2) | L | Н | L | V _{ID} | L/H | SA,A6=L, A1=H,A0=L | (Note 4) | х | Х | |
| In-system | Sector Unprotect (Note 2) | L | Н | L | V _{ID} | L/H (Note 3) | SA,A6=H, A1=H,A0=L | (Note 4) | х | Х | |
| | Temporary Sector Unprotect | х | х | Х | V _{ID} | H (Note 3) | A _{IN} | (Note 4) | (Note 4) | High-Z | |
| A9 High-Volt- age Method | Sector protect | L | V _{ID} | L | Н | H (Note 3) | SA,A9=V _{ID} , A6=L, A1=H,A0=L | (Note 4) | (Note 4) | lliah 7 | |
| age ivieti100 | Sector unprotect | L | V_{ID} | L | Н | H (Note 3) | SA,A9=V _{ID} , A6=H, A1=H,A0=L | (Note 4) | (Note 4) | High-Z | |

Legend: L=Logic Low=V_{IL}, H=Logic High=V_{IH}, V_{ID}=11.5-12.5V, V_{HH}=11.5-12.5V, X=Don't Care, SA=Sector Adress, A_{IN}=Adress In, D_{IN}=Data In, D_{OUT}=Data Out

Notes:

- 1. Addresses are A20:A0 in word mode (BYTE#=V_{IH}), A20:A-1 in byte mode (BYTE#=V_{IL}).
- 2. The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector/Sector Block Protection and Unprotection" section.
- 3. If WP#/ACC=V_{IL}, the two outermost boot sectors remain protected. If WP#/ACC=V_{IH}, the two outermost boot sector protection depends on whether they were last protected or unprotected using the method described in "Sector/Sector Block Protection and Unprotection". If WP#/ACC=V_{IH}, all sectors will be unprotected.
- 4. D_{IN} or D_{OUT} as required by command sequence, data polling, or sector protection algorithm.

Table 2. Autoselect Codes (A9 High-Voltage Method)

| | | | | A20 | A11 | | A8 | | A5 | | | DQ8~ | DQ15 | |
|---------------------------------------|-----|-----|-----|-----------|-----------|-----------------|----------|----|----------|----|----|----------------------------|----------------------------|-----------------------------------------------------|
| Description | CE# | OE# | WE# | to A12 | to A10 | A9 | to A7 | A6 | to A2 | A1 | Α0 | BYTE# = V _{IH} | BYTE# = V _{IL} | DQ7~DQ0 |
| ManufactureID:ESI | L | L | Н | Х | Х | V_{ID} | Х | L | Х | L | L | Х | Х | 4Ah |
| Device ID: ES29LV320 | L | L | Н | X | Х | V_{ID} | Х | L | Х | L | Н | 22h | Х | F6(T),F9h(B) |
| Sector Protection Verification | L | L | Н | SA | X | V_{ID} | Х | L | Х | H | L | Х | Х | 01h(protected) 00h(unprotected) |
| Security Sector Indicator Bit(DQ7) | L | L | н | X | X | V _{ID} | Х | L | Х | Ξ | н | × | Х | 99h(factory-locked), 19h(customer-lock- able) |

 $\textbf{Legend:} \ \textit{T=Top Boot Block, B} = \textit{Bottom Boot Block, L=Logic Low=V}_{\textit{IL}}, \ \textit{H=Logic High=V}_{\textit{IH}}, \ \textit{SA=Sector Address, X} = \textit{Don't care}$



Table 3. Top Boot Sector Addresses (ES29LV320DT)

| Group | Sector | Sector address | Sector Size | (X8) | (X16) | Remark |
|-------|--------------|----------------|-----------------|-----------------|-----------------|--------|
| | | A20~A12 | (Kbytes/Kwords) | Address Range | Address Range | |
| | SA0 | 000000XXX | 64/32 | 000000h~00FFFFh | 000000h~07FFFh | |
| SG0 | SA1 | 000001XXX | 64/32 | 010000h~01FFFFh | 008000h~0FFFh | |
| | SA2 | 000010XXX | 64/32 | 020000h~02FFFFh | 010000h~17FFFh | |
| | SA3 | 000011XXX | 64/32 | 030000h~03FFFFh | 018000h~01FFFFh | |
| | SA4 | 000100XXX | 64/32 | 040000h~04FFFFh | 020000h~027FFFh | |
| SG1 | SA5 | 000101XXX | 64/32 | 050000h~05FFFFh | 028000h~02FFFFh | |
| 001 | SA6 | 000110XXX | 64/32 | 060000h~06FFFFh | 030000h~037FFFh | |
| | SA7 | 000111XXX | 64/32 | 070000h~07FFFh | 038000h~03FFFFh | |
| | SA8 | 001000XXX | 64/32 | 080000h~08FFFFh | 040000h~047FFFh | |
| SG2 | SA9 | 001001XXX | 64/32 | 090000h~09FFFFh | 048000h~04FFFFh | |
| 002 | SA10 | 001010XXX | 64/32 | 0A0000h~0AFFFFh | 050000h~057FFFh | |
| | SA11 | 001011XXX | 64/32 | 0B0000h~0BFFFFh | 058000h~05FFFFh | |
| | SA12 | 001100XXX | 64/32 | 0C0000h~0CFFFFh | 060000h~067FFFh | |
| SG3 | SA13 | 001101XXX | 64/32 | 0D0000h~0DFFFFh | 068000h~06FFFFh | |
| 505 | SA14 | 001110XXX | 64/32 | 0E0000h~0EFFFh | 070000h~077FFFh | |
| | SA15 | 001111XXX | 64/32 | 0F0000h~0FFFFh | 078000h~07FFFFh | |
| | SA16 | 010000XXX | 64/32 | 100000h~10FFFFh | 080000h~087FFFh | 1 |
| SG4 | SA17 | 010001XXX | 64/32 | 110000h~11FFFFh | 088000h~08FFFFh | |
| 364 | SA18 | 010010XXX | 64/32 | 120000h~12FFFFh | 090000h~097FFFh | |
| | SA19 | 010011XXX | 64/32 | 130000h~13FFFFh | 098000h~09FFFFh | |
| | SA20 | 010100XXX | 64/32 | 140000h~14FFFFh | 0A0000h~0A7FFFh | 1 |
| 005 | SA21 | 010101XXX | 64/32 | 150000h~15FFFFh | 0A8000h~0AFFFFh | |
| SG5 | SA22 | 010110XXX | 64/32 | 160000h~16FFFFh | 0B0000h~0B7FFFh | |
| | SA23 | 010111XXX | 64/32 | 170000h~17FFFFh | 0B8000h~0BFFFFh | |
| | SA24 | 011000XXX | 64/32 | 180000h~18FFFFh | 0C0000h~0C7FFFh | |
| 000 | SA25 | 011001XXX | 64/32 | 190000h~19FFFFh | 0C8000h~0CFFFFh | |
| SG6 | SA26 | 011010XXX | 64/32 | 1A0000h~1AFFFFh | 0D0000h~0D7FFFh | Main |
| | SA27 | 011011XXX | 64/32 | 1B0000h~1BFFFFh | 0D8000h~0DFFFFh | Sector |
| | SA28 | 011100XXX | 64/32 | 1C0000h~1CFFFFh | 0E0000h~0E7FFh | 000001 |
| 007 | SA29 | 011101XXX | 64/32 | 1D0000h~1DFFFFh | 0E8000h~0EFFFFh | |
| SG7 | SA30 | 011110XXX | 64/32 | 1E0000h~1EFFFFh | 0F0000h~0F7FFh | 1 |
| | SA31 | 011111XXX | 64/32 | 1F0000h~1FFFFFh | 0F8000h~0FFFFh | |
| | SA32 | 100000XXX | 64/32 | 200000h~20FFFFh | 100000h~107FFFh | 1 |
| 000 | SA33 | 100001XXX | 64/32 | 210000h~21FFFFh | 108000h~10FFFFh | 1 |
| SG8 | SA34 | 100010XXX | 64/32 | 220000h~22FFFFh | 110000h~117FFFh | 1 |
| | SA35 | 100011XXX | 64/32 | 230000h~23FFFFh | 118000h~11FFFFh | 1 |
| | SA36 | 100100XXX | 64/32 | 240000h~24FFFFh | 120000h~127FFFh | 1 |
| | SA37 | 100101XXX | 64/32 | 250000h~25FFFFh | 128000h~12FFFFh | |
| SG9 | SA38 | 100110XXX | 64/32 | 260000h~26FFFFh | 130000h~137FFFh | 1 |
| | SA39 | 100111XXX | 64/32 | 270000h~27FFFFh | 138000h~13FFFFh | |
| | SA40 | 101000XXX | 64/32 | 280000h~28FFFFh | 140000h~147FFFh | 1 |
| | SA41 | 101001XXX | 64/32 | 290000h~29FFFFh | 148000h~14FFFh | |
| SG10 | SA42 | 101010XXX | 64/32 | 2A0000h~2AFFFFh | 150000h~157FFFh | |
| | SA43 | 101011XXX | 64/32 | 2B0000h~2BFFFFh | 158000h~15FFFFh | |
| | SA44 | 101100XXX | 64/32 | 2C0000h~2CFFFh | 160000h~167FFFh | 1 |
| | SA45 | 101101XXX | 64/32 | 2D0000h~2DFFFFh | 168000h~16FFFFh | |
| SG11 | SA46 | 101110XXX | 64/32 | 2E0000h~2EFFFFh | 170000h~177FFFh | |
| | SA47 | 101111XXX | 64/32 | 2F0000h~2FFFFFh | 178000h~17FFFFh | 1 |
| | SA48 | 110000XXX | 64/32 | 300000h~30FFFFh | 180000h~187FFFh | 1 |
| | SA49 | 110001XXX | 64/32 | 310000h~31FFFFh | 188000h~18FFFFh | - |
| SG12 | SA49 SA50 | 110010XXX | 64/32 | 320000h~32FFFFh | 190000h~197FFFh | 1 |
| | SA50 | 110010XXX | 64/32 | 330000h~33FFFFh | 198000h~19FFFFh | - |
| | SA51 | 110111XX | 64/32 | 340000h~34FFFFh | 1A0000h~1A7FFFh | - |
| | | | | | | 4 |
| SG13 | SA53 | 110101XXX | 64/32 | 350000h~35FFFFh | 1A8000h~1AFFFFh | 4 |
| | SA54 | 110110XXX | 64/32 | 360000h~36FFFFh | 1B0000h~1B7FFFh | 4 |
| | SA55 | 110111XXX | 64/32 | 370000h~37FFFFh | 1B8000h~1BFFFFh | |



Table 3. Top Boot Sector Addresses (ES29LV320DT) Continued

| Group | Sector | Sector address A20~A12 | Sector Size (Kbytes/Kwords) | (X8) Address Range | (X16) Address Range | Remark |
|--------|-----------|---------------------------|--------------------------------|-----------------------|------------------------|--------------------|
| | SA56 | 111000XXX | 64/32 | 380000h~38FFFFh | 1C0000h~1C7FFFh | |
| SG14 | SA57 | 111001XXX | 64/32 | 390000h~39FFFFh | 1C8000h~1CFFFFh | |
| 3614 | SA58 | 111010XXX | 64/32 | 3A0000h~3AFFFFh | 1D0000h~1D7FFFh | |
| | SA59 | 111011XXX | 64/32 | 3B0000h~3BFFFFh | 1D8000h~1DFFFFh | Main |
| | SA60 | 111100XXX | 64/32 | 3C0000h~3CFFFFh | 1E0000h~1E7FFFh | Sector |
| SG15 | SA61 | 111101XXX | 64/32 | 3D0000h~3DFFFFh | 1E8000h~1EFFFFh | |
| | SA62 | 111110XXX | 64/32 | 3E0000h~3EFFFFh | 1F0000h~1F7FFFh | |
| SG16 | SA63 | 111111000 | 8/4 | 3F0000h~3F1FFFh | 1F8000h~1F8FFFh | 1 |
| SG17 | SA64 | 111111001 | 8/4 | 3F2000h~3F3FFFh | 1F9000h~1F9FFFh | Boot |
| SG18 | SA65 | 111111010 | 8/4 | 3F4000h~3F5FFFh | 1FA000h~1FAFFFh | Sector |
| SG19 | SA66 | 111111011 | 8/4 | 3F6000h~3F7FFFh | 1FB000h~1FBFFFh | |
| SG20 | SA67 | 111111100 | 8/4 | 3F8000h~3F9FFFh | 1FC000h~1FCFFFh | SA69,SA70 |
| SG21 | SA68 | 111111101 | 8/4 | 3FA000h~3FBFFFh | 1FD000h~1FDFFFh | protected |
| SG22 | SA69 | 111111110 | 8/4 | 3FC000h~3FDFFFh | 1FE000h~1FEFFFh | at WP#/ ACC=low |
| SG23 | SA70 | 111111111 | 8/4 | 3FE000h~3FFFFFh | 1FF000h~1FFFFFh | ACC-IOW |
| Securi | ty Sector | 111111111 | bytes/words (256/128) | 3FFF00h~3FFFFFh | 1FFF80h~1FFFFFh | |

Note:

The addresses range is A20:A-1 in byte mode (BYTE#= V_{IL}) or A20:A0 in word mode (BYTE#= V_{IH}).



Table 4. Bottom Boot Sector Addresses (ES29LV320DB)

| Group | Sector | Sector address A20~A12 | Sector Size (Kbytes/Kwords) | (X8) Address Range | (X16) Address Range | Remark |
|-------|--------|---------------------------|--------------------------------|-----------------------|------------------------|-------------------|
| SG0 | SA0 | 000000000 | 8/4 | 000000h~001FFFh | 000000h~000FFFh | 1 |
| SG1 | SA1 | 00000001 | 8/4 | 002000h~003FFFh | 001000h~001FFFh | Boot |
| SG2 | SA2 | 00000010 | 8/4 | 004000h~005FFFh | 002000h~002FFFh | Sector |
| SG3 | SA3 | 00000011 | 8/4 | 006000h~007FFFh | 003000h~003FFFh | 000 004 |
| SG4 | SA4 | 00000100 | 8/4 | 008000h~009FFFh | 004000h~004FFFh | SA0,SA1 protected |
| SG5 | SA5 | 00000101 | 8/4 | 00A000h~00BFFFh | 005000h~005FFFh | at WP#/ |
| SG6 | SA6 | 000000110 | 8/4 | 00C000h~00DFFFh | 006000h~006FFFh | ACC=low |
| SG7 | SA7 | 000000111 | 8/4 | 00E000h~00FFFFh | 007000h~007FFFh | |
| | SA8 | 000001XXX | 64/32 | 010000h~01FFFFh | 008000h~00FFFFh | |
| SG8 | SA9 | 000010XXX | 64/32 | 020000h~02FFFFh | 010000h~017FFFh | |
| | SA10 | 000011XXX | 64/32 | 030000h~03FFFFh | 018000h~01FFFFh | |
| | SA11 | 000100XXX | 64/32 | 040000h~04FFFFh | 020000h~027FFFh | |
| SG9 | SA12 | 000101XXX | 64/32 | 050000h~05FFFFh | 028000h~02FFFFh | |
| 309 | SA13 | 000110XXX | 64/32 | 060000h~06FFFFh | 030000h~037FFFh | |
| - | SA14 | 000111XXX | 64/32 | 070000h~07FFFh | 038000h~03FFFFh | |
| | SA15 | 001000XXX | 64/32 | 080000h~08FFFFh | 040000h~047FFFh | 7 |
| SG10 | SA16 | 001001XXX | 64/32 | 090000h~09FFFFh | 048000h~04FFFFh | |
| 0010 | SA17 | 001010XXX | 64/32 | 0A0000h~0AFFFFh | 050000h~057FFFh | |
| | SA18 | 001011XXX | 64/32 | 0B0000h~0BFFFFh | 058000h~05FFFFh | |
| | SA19 | 001100XXX | 64/32 | 0C0000h~0CFFFFh | 060000h~067FFFh | |
| SG11 | SA20 | 001101XXX | 64/32 | 0D0000h~0DFFFFh | 068000h~06FFFFh | |
| 3011 | SA21 | 001110XXX | 64/32 | 0E0000h~0EFFFFh | 070000h~077FFFh | |
| - | SA22 | 001111XXX | 64/32 | 0F0000h~0FFFFh | 078000h~07FFFh | |
| | SA23 | 010000XXX | 64/32 | 100000h~10FFFFh | 080000h~087FFFh | |
| SG12 | SA24 | 010001XXX | 64/32 | 110000h~11FFFFh | 088000h~08FFFFh | |
| 3012 | SA25 | 010010XXX | 64/32 | 120000h~12FFFFh | 090000h~097FFFh | |
| | SA26 | 010011XXX | 64/32 | 130000h~13FFFFh | 098000h~09FFFFh | |
| | SA27 | 010100XXX | 64/32 | 140000h~14FFFFh | 0A0000h~0A7FFFh | |
| SG13 | SA28 | 010101XXX | 64/32 | 150000h~15FFFFh | 0A8000h~0AFFFFh | |
| 3013 | SA29 | 010110XXX | 64/32 | 160000h~16FFFFh | 0B0000h~0B7FFFh | Main |
| | SA30 | 010111XXX | 64/32 | 170000h~17FFFFh | 0B8000h~0BFFFFh | Sector |
| | SA31 | 011000XXX | 64/32 | 180000h~18FFFFh | 0C0000h~0C7FFFh | Color |
| SG14 | SA32 | 011001XXX | 64/32 | 190000h~19FFFFh | 0C8000h~0CFFFFh | |
| 0014 | SA33 | 011010XXX | 64/32 | 1A0000h~1AFFFFh | 0D0000h~0D7FFFh | |
| | SA34 | 011011XXX | 64/32 | 1B0000h~1BFFFFh | 0D8000h~0DFFFFh | |
| | SA35 | 011100XXX | 64/32 | 1C0000h~1CFFFFh | 0E0000h~0E7FFFh | |
| SG15 | SA36 | 011101XXX | 64/32 | 1D0000h~1DFFFFh | 0E8000h~0EFFFFh | |
| 0010 | SA37 | 011110XXX | 64/32 | 1E0000h~1EFFFFh | 0F0000h~0F7FFh | |
| | SA38 | 011111XXX | 64/32 | 1F0000h~1FFFFFh | 0F8000h~0FFFFh | |
| | SA39 | 100000XXX | 64/32 | 200000h~20FFFFh | 100000h~107FFFh | |
| SG16 | SA40 | 100001XXX | 64/32 | 210000h~21FFFFh | 108000h~10FFFFh | |
| | SA41 | 100010XXX | 64/32 | 220000h~22FFFFh | 110000h~117FFFh | |
| | SA42 | 100011XXX | 64/32 | 230000h~23FFFFh | 118000h~11FFFFh | |
| | SA43 | 100100XXX | 64/32 | 240000h~24FFFFh | 120000h~127FFFh | |
| SG17 | SA44 | 100101XXX | 64/32 | 250000h~25FFFFh | 128000h~12FFFFh | |
| | SA45 | 100110XXX | 64/32 | 260000h~26FFFFh | 130000h~137FFFh | |
| | SA46 | 100111XXX | 64/32 | 270000h~27FFFFh | 138000h~13FFFFh | _ |
| | SA47 | 101000XXX | 64/32 | 280000h~28FFFFh | 140000h~147FFFh | |
| SG18 | SA48 | 101001XXX | 64/32 | 290000h~29FFFh | 148000h~14FFFFh | |
| | SA49 | 101010XXX | 64/32 | 2A0000h~2AFFFFh | 150000h~157FFFh | _ |
| | SA50 | 101011XXX | 64/32 | 2B0000h~2BFFFFh | 158000h~15FFFFh | _ |
| | SA51 | 101100XXX | 64/32 | 2C0000h~2CFFFFh | 160000h~167FFFh | |
| SG19 | SA52 | 101101XXX | 64/32 | 2D0000h~2DFFFFh | 168000h~16FFFFh | |
| | SA53 | 101110XXX | 64/32 | 2E0000h~2EFFFFh | 170000h~177FFFh | |
| 1 | SA54 | 101111XXX | 64/32 | 2F0000h~2FFFFh | 178000h~17FFFFh | 1 |



Table 4. Bottom Boot Sector Addresses (ES29LV320DB) Continued

| Group | Sector | Sector address A20~A12 | Sector Size (Kbytes/Kwords) | (X8) Address Range | (X16) Address Range | Remark |
|---------|----------|---------------------------|--------------------------------|-----------------------|------------------------|--------------------------|
| | SA55 | 110000XXX | 64/32 | 300000h~30FFFFh | 180000h~187FFFh | |
| SG20 | SA56 | 110001XXX | 64/32 | 310000h~31FFFFh | 188000h~18FFFFh | |
| 3620 | SA57 | 110010XXX | 64/32 | 320000h~32FFFFh | 190000h~197FFFh | |
| | SA58 | 110011XXX | 64/32 | 330000h~33FFFFh | 198000h~19FFFFh | |
| | SA59 | 110100XXX | 64/32 | 340000h~34FFFFh | 1A0000h~1A7FFFh | 1 |
| SG21 | SA60 | 110101XXX | 64/32 | 350000h~35FFFFh | 1A8000h~1AFFFFh | 1 |
| 3621 | SA61 | 110110XXX | 64/32 | 360000h~36FFFFh | 1B0000h~1B7FFFh | 1 |
| | SA62 | 110111XXX | 64/32 | 370000h~37FFFFh | 1B8000h~1BFFFFh | Main |
| | SA63 | 111000XXX | 64/32 | 380000h~38FFFFh | 1C0000h~1C7FFFh | Sector |
| SG22 | SA64 | 111001XXX | 64/32 | 390000h~39FFFFh | 1C8000h~1CFFFFh | 1 |
| 3022 | SA65 | 111010XXX | 64/32 | 3A0000h~3AFFFFh | 1D0000h~1D7FFFh | 1 |
| | SA66 | 111011XXX | 64/32 | 3B0000h~3BFFFFh | 1D8000h~1DFFFFh | 1 |
| | SA67 | 111100XXX | 64/32 | 3C0000h~3CFFFFh | 1E0000h~1E7FFFh | |
| SG23 | SA68 | 111101XXX | 64/32 | 3D0000h~3DFFFFh | 1E8000h~1EFFFFh | |
| 3623 | SA69 | 111110XXX | 64/32 | 3E0000h~3EFFFFh | 1F0000h~1F7FFFh | 1 |
| | SA70 | 111111XXX | 64/32 | 3F0000h~3FFFFFh | 1F8000h~1FFFFFh | |
| Securit | y Sector | 000000000 | bytes/words (256/128) | 000000h~0000FFh | 000000h~00007Fh | |

Note

The addresses range is A20:A-1 in byte mode (BYTE#= V_{IL}) or A20:A0 in word mode (BYTE#= V_{IH}).



In-System Protection / Unprotection Method

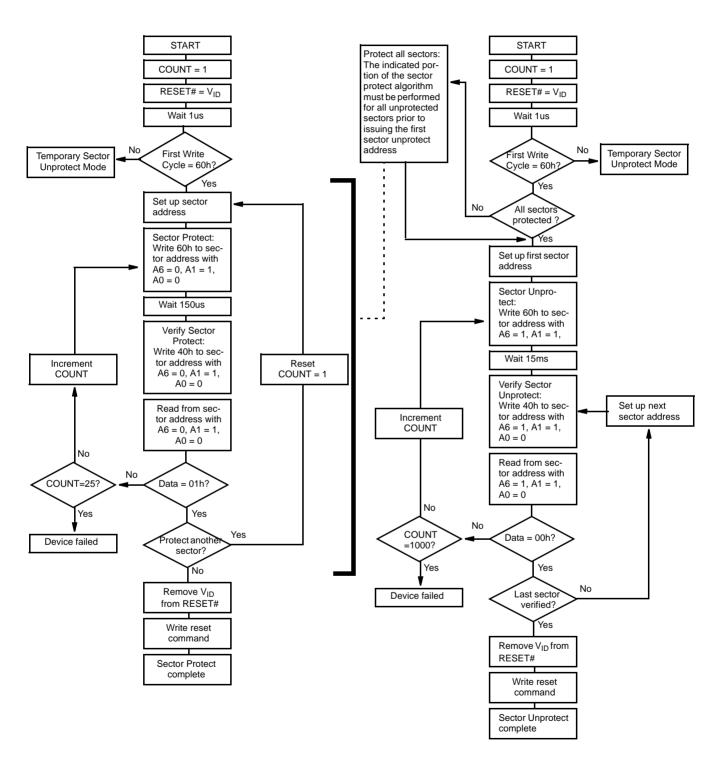


Figure 3. In-System Sector Protect Algorithm

Figure 4. In-System Sector
Unprotect Algorithm



A9 High-Voltage Method

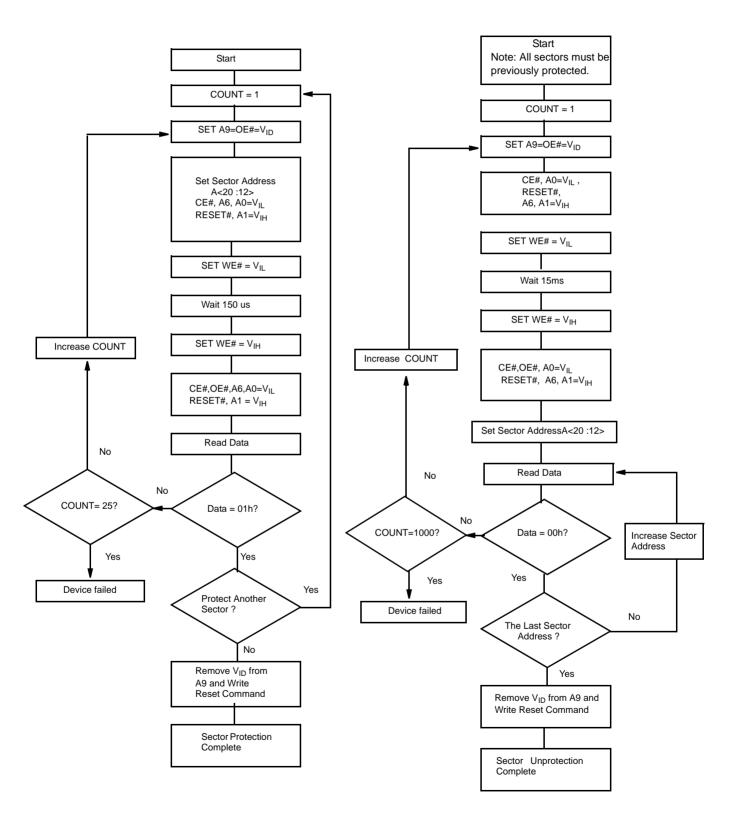


Figure 5. Sector Protection Algorithm (A9 High-Voltage Method)

Figure 6. Sector Un-Protection Algorithm (A9 High-Voltage Method)



Common Flash Memory Interface (CFI)

CFI is supported in the ES29LV320 device. The Common Flash Interface (CFI) specification outlines device and host system software interrogation handshake, which allows specific vendor-specified software algorithms to be used for entire families of devices. Software support can then be device-independent, JEDEC ID-independent, and forward- and backward-compatible for the specified flash device families. Flash vendors can standardize their existing interfaces for long-term compatibility.

This device enters the CFI Query mode when the system writes the CFI query command, 98h, to address 55h in word mode (or address AAh in byte mode), any time the device is ready to read array data. The system can read CFI information at the addresses given in Tables 5-8. To terminate reading CFI data, the system must write the reset command. The CFI query command can be written to the system when the device is in the autoselect mode or the erase-suspend-read mode. The device enters the CFI query mode, and the system can read CFI data at the addresses given in Tables 5-8. When the reset command is written, the device returns respectively to the read mode or erase-suspend-read mode.

Table 5. CFI Query Identification String

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description |
|--------------------------|--------------------------|-------|--------------------------------------------------------------|
| 10h | 20h | 0051h | Query Unique ASCII string "QRY" |
| 11h | 22h | 0052h | |
| 12h | 24h | 0059h | |
| 13h | 26h | 0002h | Primary OEM Command Set |
| 14h | 28h | 0000h | |
| 15h | 2Ah | 0040h | Address for Primary Extended Table |
| 16h | 2Ch | 0000h | |
| 17h | 2Eh | 0000h | Alternate OEM Command Set(00h = none exists) |
| 18h | 30h | 0000h | |
| 19h | 32h | 0000h | Address for Alternate OEM Extended Table (00h = none exists) |
| 1Ah | 34h | 0000h | |

Table 6. System Interface String

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description |
|--------------------------|--------------------------|-------|-----------------------------------------------------------------------------|
| 1Bh | 36h | 0027h | Vcc Min. (write/erase) D7-D4: volt, D3-D0: 100 millivolt |
| 1Ch | 38h | 0036h | Vcc Max. (write/erase) D7-D4: volt, D3-D0: 100 millivolt |
| 1Dh | 3Ah | 0000h | Vpp Min. voltage (00h = no Vpp pin present) |
| 1Eh | 3Ch | 0000h | Vpp Max. voltage (00h = no Vpp pin present) |
| 1Fh | 3Eh | 0004h | Typical timeout per single byte/word write 2 ^N us |
| 20h | 40h | 0000h | Typical timeout for Min. size buffer write 2^{N} us (00h = not supported) |
| 21h | 42h | 000Ah | Typical timeout per individual block erase 2 ^N ms |
| 22h | 44h | 0000h | Typical timeout for full chip erase 2 ^N ms (00h = not supported) |
| 23h | 46h | 0005h | Max. timeout for byte/word write 2 ^N times typical |
| 24h | 48h | 0000h | Max. timeout for buffer write 2 ^N times typical |
| 25h | 4Ah | 0004h | Max. timeout per individual block erase 2 ^N times typical |
| 26h | 4Ch | 0000h | Max. timeout for full chip erase 2^N times typical (00h = not supported) |



Table 7. Device Geometry Definition

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description |
|--------------------------|--------------------------|-------|---------------------------------------------------------------------------------------------------|
| 27h | 4Eh | 0016h | Device Size = 2 ^N byte |
| 28h | 50h | 0002h | Flash Device Interface description |
| 29h | 52h | 0000h | 02 = x8, x16 Asynchronous |
| 2Ah | 54h | 0000h | Max. number of bytes multi-byte write = 2 ^N (00h = not supported) |
| 2Bh | 56h | 0000h | |
| 2Ch | 58h | 0002h | Number of Erase Block Regions within device |
| 2Dh | 5Ah | 0007h | Erase Block Region 1 Information Number of identical size erase block = 0007h+1 =8 |
| 2Eh | 5Ch | 0000h | |
| 2Fh | 5Eh | 0020h | Erase Block Region 1 Information Number of identical size erase block = 0020h * 256byte = 8Kbyte |
| 30h | 60h | 0000h | |
| 31h | 62h | 003Eh | Erase Block Region 2 Information Number of identical size erase block = 003Eh+1 =63 |
| 32h | 64h | 0000h | |
| 33h | 66h | 0000h | Erase Block Region 2Information Number of identical size erase block = 0100h * 256byte = 64Kbyte |
| 34h | 68h | 0001h | |
| 35h | 6Ah | 0000h | Erase Block Region 3 Information |
| 36h | 6Ch | 0000h | |
| 37h | 6Eh | 0000h | Erase Block Region 3 Information |
| 38h | 70h | 0000h | |
| 39h | 72h | 0000h | Erase Block Region 4 Information |
| 3Ah | 74h | 0000h | |
| 3Bh | 76h | 0000h | Erase Block Region 4 Information |
| 3Ch | 78h | 0000h | |



Table 8. Primary Vendor-Specific Extended Query

| Addresses (Word Mode) | Addresses (Byte Mode) | Data | Description |
|--------------------------|--------------------------|-------------------------|-------------------------------------------------------------------------------------------------------|
| 40h 41h 42h | 80h 82h 84h | 0050h 0052h 0049h | Query-unique ASCII string "PRI" |
| 43h | 86h | 0031h | Major version number, ASCII |
| 44h | 88h | 0031h | Minor version number, ASCII |
| 45h | 8Ah | 0000h | Address Sensitive Unlock (Bits 1-0) 0 = Required, 1 = Not required Silicon Revision Number (Bits 7-2) |
| 46h | 8Ch | 0002h | Erase Suspend 0 = Not Supported, 1 = To Read Only, 2 = To Read & Write |
| 47h | 8Eh | 0004h | Sector Protect 0 = Not Supported, X = Number of sectors in per group |
| 48h | 90h | 0001h | Sector Temporary Unprotect 00 = Not Supported, 01 = Supported |
| 49h | 92h | 0004h | Sector Protect/Unprotect scheme 04 = In-System Method and A9 High-Voltage Method |
| 4Ah | 94h | 0000h | Simultaneous Operation 00 = Not Supported |
| 4Bh | 96h | 0000h | Burst Mode Type 00 = Not Supported, 01 = Supported |
| 4Ch | 98h | 0000h | Page Mode Type 00 = Not Supported, 01 = 4 Word Page, 02 = 8 Word Page |
| 4Dh | 9Ah | 00B5h | ACC(Acceleration) Supply Minimum 00h = Not Supported, D7-D4: Volt, D3-D0: 100mV |
| 4Eh | 9Ch | 00C5h | ACC(Acceleration) Supply Maximum 00h = Not Supported, D7-D4: Volt, D3-D0: 100mV |
| 4Fh | 9Eh | 000Xh | Top/Bottom Boot Sector Flag 02h = Bottom Boot Device, 03h = Top Boot Device |



COMMAND DEFINITIONS

Writing specific address and data commands or sequences into the command register initiates device operations. Table 9 defines the valid register command sequences. Note that writing incorrect address and data values or writing them in the improper sequence may place the device in an unknown state. A reset command is required to return the device to normal operation.

All addresses are latched on the falling edge of WE# or CE#, whichever happens later. All data is latched on the rising edge of WE# or CE#, whichever happens first. Refer to the AC Characteristics section for timing diagrams.

READING ARRAY DATA

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. The device is ready to read array data after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the device enters the erase-suspend-read mode, after which the system can read data from any non-erase-suspended sector. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See the Erase Suspend/Erase Resume Commands section for more information.

The system must issue the reset command to return the device to the read (or erase-suspend-read) mode if DQ5 goes high during an active program or erase operation, or if the device is in the autoselect mode. See the next section, Reset Command, for more information.

See also Requirements for Reading Array Data in

the Device Bus Operations section for more information. The Read-Only Operations table provides the read parameters, and Fig. 18 shows the timing diagram

RESET COMMAND

Writing the reset command resets the device to the read or erase-suspend-read mode. Address bits are don't cares for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the device to which the system was writing to the read mode. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the device to which the system was writing to the read mode. If the program command sequence is written to a sector that is in the Erase Suspend mode, writing the reset command returns the device to the erase-suspend-read mode. Once programming begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command must be written to return to the read mode. If the device entered the autoselect mode while in the Erase Suspend mode, writing the reset command returns the device to the erase-suspend-read mode.

If DQ5 goes high during a program or erase operation, writing the reset command returns the device to the read mode (or erase-suspend-read mode if the device was in Erase-Suspend).





Command Definitions

Table 9. ES29LV320 Command Definitions

| Command Sequence | | 10 | Bus Cycles (Notes 2~5) | | | | | | | | | | | | |
|-------------------------|----------------------------------------|------|------------------------|--------|------|------------|-------|---------------|---------|---------|----------|-------|------|-------|------|
| | | | Cycles | First | | Second | | Third | | Fourth | | Fifth | | Sixth | |
| | (Note 1) | | | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data |
| Read (Note 6) | | 1 | RA | RD | | | | | | | | | | | |
| Reset (Note 7) | | 1 | XXX | F0 | | | | | | | | | | | |
| | Manufacturer ID | Word | 4 | 555 | AA | 2AA | 55 | 555 | 90 | X00 | 4.0 | | | | |
| | | Byte | 4 | AAA | AA | 555 | 55 | AAA | 90 | X00 | 4A | | | | |
| <u>~</u> | D : 1D | Word | 4 | 555 | AA | 2AA | 55 | 555 | 90 | X01 | (See | | | | |
| ote 8) | Device ID | Byte | 4 | AAA | AA | 555 | 55 | AAA | 90 | X02 | Table 2) | | | | |
| Ž | Security Sector Fac | Word | 4 | 555 | | 2AA | | 555 | 00 | X03 | 00/40 | | | | |
| elect | tory Protect (Note 9) | Byte | 4 | AAA | AA | 555 | 55 | AAA | 90 | X06 | 99/19 | | | | |
| Autoselect (Note | Sector Protect Verify | Word | 4 | 555 | AA | 2AA 55 | 555 | 00 | (SA)X02 | 00/01 | | | | | |
| ¥ | (Note 10) | Byte | 4 | AAA | AA | 555 | ວວ | AAA | 90 | (SA)X04 | 00/01 | | | | |
| F-+ 0 | Enter Security Sector Region Word Byte | | 3 | 555 | | 2AA | 55 | 555 | 88 | | | | | | |
| Enter S | | | 3 | AAA | - AA | 555 | 55 | AAA | | | | | | | |
| Word | | Word | 555 | | 2AA | 55 | 555 | 00 | XXX | 00 | | | | | |
| EXIT Set | curity Sector Region | Byte | 4 | AAA AA | AA | 555 | 55 | AAA | 90 | 90 XXX | 00 | | | | |
| D | Word | | 4 | 555 | 2AA | | 555 | 40 | DΛ | PD | | | | | |
| Progran | n | Byte | 4 | AAA | AA | 555 | 55 AA | AAA | A0 | PA | PD | | | | |
| Halada | Domana | Word | 555 | | 2AA | | 555 | 555 AAA 20 | | | | | | | |
| Unlock | Bypass | Byte | 3 | AAA AA | 555 | 55 | AAA | | | | | | | | |
| Unlock | Bypass Program (Note 11 |) | 2 | XXX | A0 | PA | PD | | | | | | | | |
| Unlock | Bypass Reset (Note 12) | | 2 | XXX | 90 | XXX | 00 | | | | | | | | |
| Chip Erase | | Word | 6 | 555 | | 2AA 555 | 55 | 555 | 80 | 555 | AA | 2AA | 55 | 555 | 1 |
| | | Byte | | AAA | AA | | 55 | AAA | | AAA | | 555 | | AAA | 10 |
| Sector Erase | | Word | | 555 | | 2AA | | 555 | 00 | 555 | AA | 2AA | | 0.4 | 00 |
| | | Byte | 6 | 6 AAA | AA | 555 | 55 | AAA | 80 | AAA | | 555 | 55 | SA | 30 |
| Erase Suspend (Note 13) | | 1 | XXX | В0 | | | | | | | | | | | |
| Erase Resume (Note 14) | | 1 | XXX | 30 | | | | | | | | | | | |
| CEL C: | on, (Note 45) | Word | 4 | 55 | | | | | | | | | | | |
| CFI Que | ery (Note 15) | Byte | 1 ' | AA | 98 | | | | | | | | | | |

Legend:

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation

PA = Address of the memory location to be programmed.

Addresses latch on the falling edge of the WE# or CE# pulse, whichever happens later.

PD = Data to be programmed at location PA. Data latches on the rising edge of WE# or CE# pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A20-A12 uniquely select any sector.

Notes:

- 1. See Table 1 for description of bus operations.
- 2. All values are in hexadecimal.
- 3. Except for the read cycle and the fourth cycle of the autoselect command sequence, all bus cycles are write cycles.
- Data bits DQ15-DQ8 are don't care in command sequences, except for RD and PD
- 5. Unless otherwise noted, address bits A20-A11 are don't cares.
- No unlock or command cycles required when device is in read mode.
- 7. The Reset command is required to return to the read mode (or to the erase-suspend-read mode if previously in Erase Suspend) when a device is in the autoselect mode, or if DQ5 goes high (while the device is providing status information).
- 8. The fourth cycle of the autoselect command sequence is a read cycle. Data bits DQ15-DQ8 are don't care. See the Autoselect Command Sequence section for more information.

- The data is 99h for factory locked and 19h for not factory locked.
- 10. The data is 00h for an unprotected sector and 01h for a protected sector.
- 11. The Unlock Bypass command is required prior to the Unlock-Bypass Program command.
- The Unlock Bypass Reset command is required to return to the read mode when the device is in the unlock bypass mode.
- 13. The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode. The Erase Suspend command is valid only during a sector erase operation.
- 14. The Erase Resume command is valid only during the Erase Suspend mode.
- 15. Command is valid when device is ready to read array data or when device is in autoselect mode.



AUTOSELECT COMMAND

The autoselect command sequence allows the host system to access the manufacturer and device codes, and determine whether or not a sector is protected, including information about factory-locked or customer lockable version.

| Identifier Code | Address | Data |
|---------------------------------|---------|------------------|
| Manufacturer ID | 00h | 4Ah |
| Device ID | 01h | F6(T), F9h(B) |
| Security Sector Factory Protect | 03h | 99 / 19 |
| Sector Group Protect Verify | (SA)02h | 00 / 01 |

Table 9 shows the address and data requirements. This method is an alternative to "A9 high-voltage method" shown in Table 2, which is intended for PROM programmers and requires V_{ID} on address pin A9. The autoselect command sequence may be written to an address within sector that is either in the read mode or erase-suspend-read mode. The auto-select command may not be written while the device is actively programming or erasing. The autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the autoselect command. The device then enters the autoselect mode. The system may read at any address any number of times without initiating another autoselect command sequence.

Once after the device enters the auto-select mode, the manufacture ID code (4Ah) can be accessed by one of two ways. Just one read cycle (with A6, A1 and A0 = 0) can be used. Or four consecutive read cycles (with A6 = 1 and A1, A0 = 0) for continuation codes (7Fh) and then another last cycle for the code (4Ah) (with A6, A1 and A0 = 0) can be used for reading the manufacturer code.

- 4Ah (one-cycle read)
- 7Fh 7Fh 7Fh 4Ah (Five-cycle read)

The system must write the reset command to return to the read mode (or erase-suspend-read mode if the device was previously in Erase Suspend).

SECURITY SECTOR COMMAND

In the ES29LV320 device, the security sector region (256 bytes) provides a secured data area containing a random, sixteen-byte electronic serial number(ESN) or customer's security codes. The security sector region can be accessed by issuing the three-cycle Enter Security Sector command sequence. The device continues to access the security sector region until the system issues the four-cycle Exit Security Sector command sequence. The Exit Security Sector command sequence returns the device to normal operation. Table 9 shows the address and data requirements for both command sequences. Note that the accelerated programming function by WP#ACC and unlock bypass mode are not available when the device has entered the security sector. Refer to the Fig. 7 for the security sector operation.

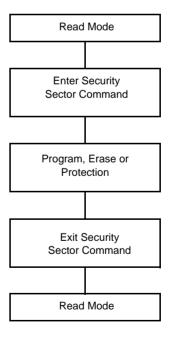
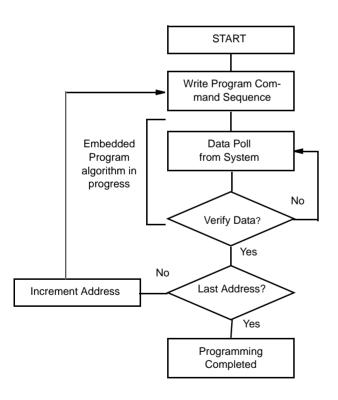


Figure 7. Security Sector Operation



BYTE / WORD PROGRAM

The system may program the device by word or byte, depending on the state of the BYTE# pin. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is not required to provide further controls or timings. The device automatically provides internally generated program pulses and verifies the programmed cell margin. Table 9 shows the address and data requirements for the byte program command sequence. Note that the autoselect, commands related with the security sector, and CFI modes are unavailable while a programming operation is in progress.



Note: See Table 9 for program command sequence

Figure 8. Program Operation

Program Status Bits: DQ7, DQ6 or RY/BY#

When the Embedded Program algorithm is complete, the device then returns to the read mode and addresses are no longer latched. The system can determine the status of the program operation by using DQ7, DQ6, or RY/BY#. Refer to the Write Operation Status section Table 10 for information on these status bits.

Any Commands Ignored during Programming Operation

Any commands written to the device during the Embedded Program algorithm are ignored. Note that a hardware reset can immediately terminates the program operation. The program command sequence should be reinitiated once the device has returned to the read mode, to ensure data integrity.

Programming from "0" back to "1"

Programming is allowed in any sequence and across sector boundaries. But a bit cannot be programmed from "0" back to a "1". Attempting to do so may cause the device to set DQ5 = 1, or cause the DQ7 and DQ6 status bits to indicate the operation was successful. However, a succeeding read will show that the data is still "0". Only erase operations can convert a "0" to a "1"

Unlock Bypass

In the ES29LV320 device, an unlock bypass program mode is provided for faster programming operation. In this mode, two cycles of program command sequences can be saved. To enter this mode, an unlock bypass enter command should be first written to the system. The unlock bypass enter command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock-bypass program mode. A two-cycle unlock bypass program command sequence is all that is required to program in this mode. The first cycle in this sequence contains the unlock bypass program set-up command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 9 shows the requirements for the command sequence.



During the unlock-bypass mode, only the unlock-bypass program and unlock-bypass reset commands are valid. To exit the unlock-bypass mode, the system must issue the two-cycle unlock-bypass reset command sequence. The first cycle must contain the data 90h. The second cycle need to only contain the data 00h. The device then returns to the read mode.

- Unlock Bypass Enter Command
- Unlock Bypass Reset Command
- Unlock Bypass Program Command

Unlock Bypass Program during WP#/ACC Accelerated Program Mode

The device offers accelerated program operations through the WP#/ACC pin. When the system asserts V_{HH} on the WP#/ACC pin, the device automatically enters the unlock bypass mode. The system may then write the two-cycle unlock bypass program command sequence. The device uses the higher voltage on the WP#/ACC pin to accelerate the operation. Note that the WP#/ACC pin must not be at V_{HH} in any operation other than accelerated programming, or device damage may result. In addition, the WP#/ACC pin must not be left floating or unconnected; inconsistent behavior of the device may result. Fig. 8 illustrates the algorithm for the program operation. Refer to the Erase and Program Operations table in the AC Characteristics section for parameters, and Fig. 22 for timing diagrams.

CHIP ERASE COMMAND

To erase the entire memory, a chip erase command is used. This command is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The chip erase command erases the entire memory including all other sectors except the protected sectors, but the internal erase operation is performed on a single sector base.

Embedded Erase Algorithm

The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

Table 9 shows the address and data requirements for the chip erase command sequence. Note that the autoselect, security sector, and CFI modes are unavailable while an erase operation is in progress

Erase Status Bits: DQ7, DQ6, DQ2, or RY/BY#

When the Embedded Erase algorithm is complete, the device returns to the read mode and addresses are no longer latched. The system can determine the status of the erase operation by using DQ7, DQ6, DQ2, or RY/BY#. Refer to the Write Operation Status section Table 10 for information on these status bits.

Commands Ignored during Erase Operation

Any command written during the chip erase operation are ignored. However, note that a hardware reset immediately terminates the erase operation. If that occurs, the chip erase command sequence should be reinitiated once the device has returned to reading array data. to ensure data integrity. Fig. 9 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Fig. 23 section for timing diagrams.

SECTOR ERASE COMMAND

By using a sector erase command, a single sector or multiple sectors can be erased. The sector erase command is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock cycles are written, and are then followed by the address of the sector to be erased, and the sector erase command. Table 9 shows the address and data requirements for the sector erase command sequence. Note that the autoselect, security sector, and CFI modes are unavailable while an erase operation is in progress.

Embedded Sector Erase Algorithm

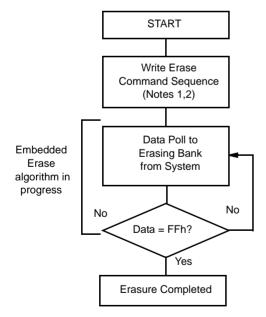
The device does not require the system to preprogram prior to erase. The Embedded Erase algorithm automatically programs and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings these operations.



Sector Erase Time-out Window and DQ3

After the command sequence is written, a sector erase time-out of 50us occurs. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50 us, otherwise the last address and command may not be accepted, and erasure may begin. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be reenabled after the last Sector Erase command is written. The system can monitor DQ3 to determine if the sector erase timer has timed out (See the section on DQ3:Sector Erase Timer.). The time-out begins from the rising edge of the final WE# pulse in the command sequence.

Any command other than Sector Erase or Erase Suspend during the time-out period resets the device to the read mode. The system must rewrite the command sequence and any additional addresses and commands.



Notes:

- 1. See Table 9 for erase command sequence
- 2. See the section on DQ3 for information on the sector erase timer

Figure 9. Erase Operation

Status Bits: DQ7,DQ6,DQ2, or RY/BY#

When the Sector Erase Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched. Note that while the Embedded Erase operation is in progress, the system can read data from the non-erasing sector. The system can determine the status of the erase operation by reading DQ7,DQ6,DQ2, or RY/BY# in the erasing sector. Refer to the Write Operation Status section Table 10 for information on these status bits.

Valid Command during Sector Erase

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. However, note that a **hardware reset** immediately terminates the erase operation. If that occurs, the sector erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

Fig. 9 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Fig. 23 section for timing diagrams.

ERASE SUSPEND/ERASE RESUME

An erase operation is a long-time operation so that two useful commands are provided in the ES29LV320 device Erase Suspend and Erase Resume Commands. Through the two commands, erase operation can be suspended for a while and the suspended operation can be resumed later when it is required. While the erase is suspended, read or program operations can be performed by the system.

Erase Suspend Command, (B0h)

The Erase Suspend command, B0h, allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the **50us time-out** period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm. When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of **20us** to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.



Read and Program during Erase-Suspend-Read Mode

After the erase operation has been suspended, the device enters the erase-suspend-read mode. The system can read data from or program data to any sector not selected for erasure. (The device "erase suspends" all sectors selected for erasure.) Reading at any address within erase-suspended sectors produces status information on DQ7-DQ0. The system can use DQ7, or DQ6 and DQ2 together, to determine if a sector is actively erasing or is erase-suspended. Refer to the Write Operation Status section for information on these status bits (Table 10).

After an erase-suspended program operation is complete, the device returns to the erase-suspend-read mode. The system can determine the status for the program operation using the DQ7 or DQ6 status bits, just as in the standard Byte Program operation. Refer to the Write Operation Status section for more information.

Autoselect during Erase-Suspend- Read Mode

In the erase-suspend-read mode, the system can also issue the autoselected command sequence. Refer to the Autoselect Mode and Autoselect Command Sequence section for details (Table 9).

Erase Resume Command

To resume the sector erase operation, the system must write the Erase Resume command. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the chip has resumed erasing.



COMMAND DIAGRAM

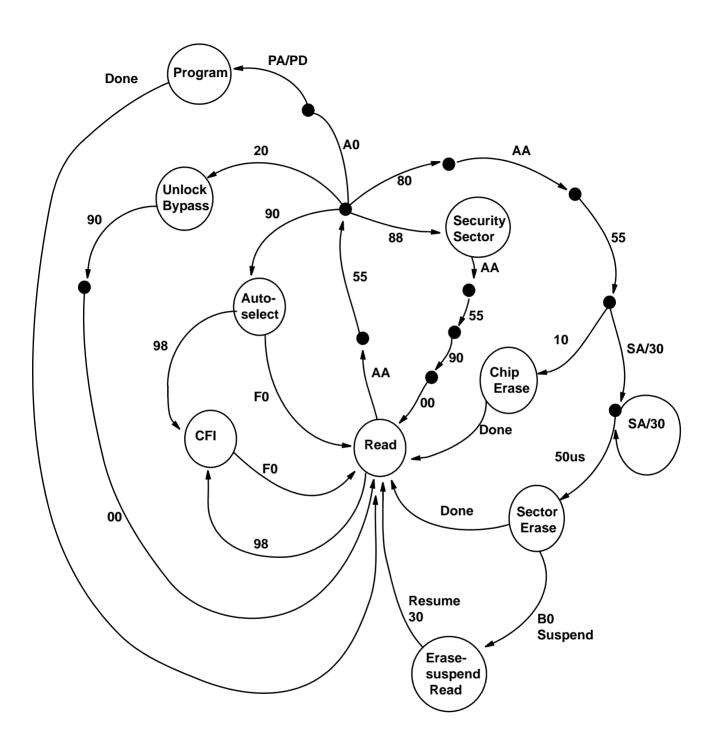


Figure 10. Command Diagram



WRITE OPERATION STATUS

In the ES29LV320 device, several bits are provided to determine the status of a program or erase operation: DQ2, DQ3, DQ5, DQ6, DQ7 and RY/BY#. Table 10 and the following subsections describe the function of these bits. DQ7 and DQ6 each offer a method for determining whether a program or erase operation is complete or in progress. The device also provides a hardware-based output signal, RY/BY#, to determine whether an Embedded Program or Erase operation is in progress or has been completed.

DQ7 (DATA# POLLING)

The Data# Polling bit, DQ7, indicates to the host system whether an Embedded Program or Erase algorithm is in progress or completed, or whether a device is in Erase Suspend. Data# Polling is valid after the rising edge of the final WE# pulse in the command sequence.

During Programming

During the Embedded Program algorithm, the device outputs on DQ7 the **complement** of the datum programmed to DQ7. This DQ7 status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to DQ7. The system must provide the program address to read valid status information on DQ7. If a program address falls within a **protected sector**, Data# Polling on DQ7 is active for approximately **250ns**, then the device returns to the read mode.

During Erase

During the Embedded Erase algorithm, Data# Polling produces a "0" on DQ7. When the Embedded

Erase algorithm is complete, or if the device enters the Erase Suspend mode, Data# polling produces a "1" on DQ7. The system must provide an address within any of the sectors selected for erasure to read valid status information on DQ7.

Erase on the Protected Sectors

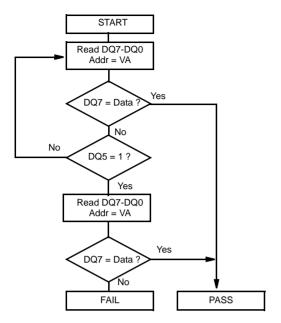
After an erase command sequence is written, if all sectors selected for erasing are protected, Data# Polling on DQ7 is active for approximately **1.8us**, then the device returns to the read mode. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. However, if the system reads DQ7 at an address within a protected sector, the status may not be valid.

Data# Polling Algorithm

Just prior to the completion of an Embedded Program or Ease operation, DQ7 may change asynchronously with DQ0-DQ6 while Output Enable(OE#) is asserted low. That is, this device may change from providing status information to valid data on DQ7. Depending on when the system samples the DQ7 output, it may read the status or valid data. Even if the device has completed the program or erase operation and DQ7 has valid data, the data outputs on DQ0-DQ7 will appear on successive read cycles.

Table 10 shows the outputs for Data# Polling on DQ7. Fig. 11 shows the Data# Polling algorithm. Fig. 24 in the AC Characteristics section shows the Data# Polling timing diagram.





Notes:

- VA = Valid address for programming. During a sector erase operation, a valid address is any sector address within the sector being erased. During chip erase, a valid address in any non-protected sector address.
- 2. DQ7 should be rechecked even if DQ5 = "1" because DQ7 may change simultaneously with DQ5

Figure 11. Data# Polling Algorithm

RY/BY# (READY/BUSY#)

The RY/BY# is a dedicated, open-drain output pin which indicates whether an Embedded Algorithm is in progress or complete. The RY/BY# status is valid after the rising edge of the final WE# pulse in the command sequence. Since RY/BY# is an open-drain output, several RY/BY# pins can be tied together in parallel with a pull-up resistor to Vcc. If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is in the read mode, the standby mode, or in the erase-suspend-read mode. Table 10 shows the outputs for RY/BY#.

DQ6 (TOGGLE BIT I)

Toggle Bit I on DQ6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the

Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge of the final WE# pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out. During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause DQ6 to toggle. The system may use either OE# or CE# to control the read cycles. When the operation is complete, DQ6 stops toggling.

The system can use DQ6 and DQ2 together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), DQ6 toggles. When the device enters the Erase Suspend mode, DQ6 stops toggling. However, the system must also use DQ2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use DQ7(see the subsection on DQ7:Data# Polling). DQ6 also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 10 shows the outputs for Toggle Bit I on DQ6. Fig. 12 shows the toggle bit algorithm. Fig. 25 in the "AC Characteristics" section shows the toggle bit timing diagrams. Fig. 26 shows the differences between DQ2 and DQ6 in graphical form. See also the subsection on DQ2: (Toggle Bit II).

Toggling on the Protected Sectors

After an erase command sequence is written, if all sectors selected for erasing are protected, DQ6 toggles for approximately **1.8us**, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. If a program address falls within a protected sector, DQ6 toggles for approximately **250ns** after the program command sequence is written, then returns to reading array data.

DQ2 (TOGGLE BIT II)

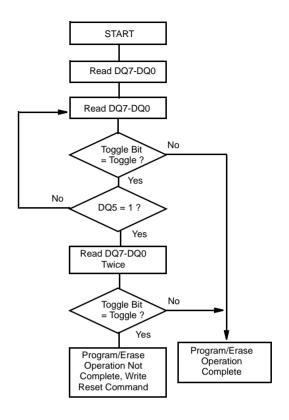
The "Toggle Bit II" on DQ2, when used with DQ6, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final WE# pulse in the command sequence DQ2



toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either OE# or CE# to control the read cycles.) But DQ2 cannot distinguish whether the sector is actively erasing or is erasesuspended. DQ6. by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 10 to compare outputs for DQ2 and DQ6. Fig. 12 shows the toggle bit algorithm in flowchart form. and the section "DQ2: Toggle Bit II" explains the algorithm. See also the DQ6: Toggle Bit I subsection. Fig. 25 shows the toggle bit timing diagram. Fig. 26 shows how differently DQ2 operates compared with DQ6.

Reading Toggle Bits DQ6/DQ2

Refer to Fig. 12 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read DQ7-DQ0 at least twice in a row to determine whether a toggle bit is toggling. Typically, the system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ7-DQ0 on the following read cycle. However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ5 is high (see the section on DQ5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not completed the operation successfully, and the system must write the reset command to return to reading array data. The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ5 has not gone high. The system may continue to monitor the toggle bit and DQ5 through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, this system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Fig. 12).



Note:

The system should recheck the toggle bit even if DQ5 = "1" because the toggle bit may stop toggling as DQ5 changes to "1". See the subsections on DQ6 and DQ2 for more information.

Figure 12. Toggle Bit Algorithm



DQ5 (EXCEEDED TIMING LIMITS)

DQ5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions DQ5 produces a "1", indicating that the program or erase cycle was not successfully completed. The device may output a "1" on DQ5 if the system tries to program a "1" to a location that was previously programmed to "0" Only an erase operation can change a "0" back to a "1". Under this condition, the device halts the operation, and when the timing limit has been exceeded, DQ5 produces a "1". Under both these conditions, the system must write the reset command to return to the read mode.

DQ3 (SECTOR ERASE TIMER)

After writing a sector erase command sequence, the system may read DQ3 to determine whether or not erasure has begun. (The sector erase time does not apply to the chip erase command.)

If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out period is complete, DQ3 switches from a "0" to a"1". If the time between additional sector erase commands from the system can be assumed to be less than 50us, the system need not monitor DQ3. See also the Sector Erase Command Sequence section. After the sector erase command is written, the system should read the status of DQ7 (Data# Polling) or DQ6 (Toggle Bit I) to ensure that the device has accepted the command sequence, and then read DQ3. If DQ3 is "1", the Embedded Erase algorithm has begun; all further commands (except Erase Suspend) are ignored until the erasure operation is complete. If DQ3 is "0", the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of DQ3 prior to and following each subsequent sector erase command. If DQ3 is high on the second status check, the last command might not have been accepted. In Table 10, DQ3 status operation is well defined and summarized with other status bits, DQ7, DQ6, DQ5, and DQ2.

Table 10. Write Operation Status

| | Status | | DQ7 (Note 2) | DQ6 | DQ5 (Note 1) | DQ3 | DQ2 (Note 2) | RY/ BY# |
|-------------------------|-------------------|-------------------------------|-----------------|-----------|-----------------|-----------|-----------------|------------|
| Standard | Embedded Program | DQ7# | Toggle | 0 | N/A | No toggle | 0 | |
| Mode | Embedded Erase A | 0 | Toggle | 0 | 1 | Toggle | 0 | |
| | Erase-Suspend- | Erase Suspended Sector | 1 | No toggle | 0 | N/A | Toggle | 1 |
| Erase Sus- pend Mode | Read | Non-Erase Suspended Sector | Data | Data | Data | Data | Data | 1 |
| | Erase-Suspend-Pro | Erase-Suspend-Program | | Toggle | 0 | N/A | N/A | 0 |

Notes:

^{1.} DQ5 switches to "1" when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. Refer to the section on DQ5 for more information.

^{2.} DQ7 and DQ2 require a valid address when reading status information. Refer to the appropriate subsection for further details.



ABSOLUTE MAXIMUM RATINGS

Storage Temperature

Plastic Packages-65°C to +150°C

Ambient Temperature

with Power Applied-65°C to +125°C

Voltage with Respect to Ground

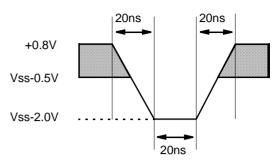
| Vcc (Note 1) | 0.5V to +4.0V |
|-------------------------------|-----------------------|
| A9, OE#, RESET# and WP#/ACC (| Note 2)0.5V to +12.5V |
| All other pins (Note 1) | -0.5V to Vcc + 0.5V |

Output Short Circuit Current (Note 3) 200 mA

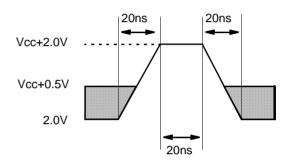
Notes:

- 1. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, input or I/O pins may overshoot Vss to -2.0V for periods of up to 20ns. Maximum DC voltage on input or I/O pins is Vcc+0.5V. See Fig. 13. During voltage transition, input or I/O pins may overshoot to Vcc+2.0V for periods up to 20ns. See Fig. 13.
- 2. Minimum DC input voltage on pins A9, OE#, RESET#, and WP# /ACC is -0.5V. During voltage transitions, A9, OE#, WP#/ACC, and RESET# may overshoot Vss to -2.0V for periods of up to 20ns. See Fig. 13. Maximum DC input voltage on pin A9 is +12.5V which may overshoot to +14.0V for periods up to 20ns. Maximum DC input voltage on WP#/ACC is +9.5V which may overshoot to +12.0V for periods up to 20ns.
- 3. No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this datasheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.



Negative Overshoot



Positive Overshoot

Figure 13. Maximum Overshoot Waveform

OPERATING RANGES

Industrial (I) Devices

Ambient Temperature (T_A).....-40°C to +85°C

Commercial Devices

Ambient Temperature (T_A)......0°C to +70°C

Vcc Supply Voltages

Vcc for all devices2.7V to 3.6V Vcc for regulated voltage range3.0V to 3.6V

Operating ranges define those limits between which the functionality of the device is guaranteed.



DC CHARACTERISTICS

Table 11. CMOS Compatible

| Parameter Symbol | Parameter Description | Test Conditions | Min | Тур | Max | Unit | |
|---------------------|-----------------------------------------------------------------------------------------|-----------------------------------------------------|-----------|---------|------|--------------|----|
| I _{LI} | Input Load Current | V _{IN} =Vss to Vcc Vcc=Vcc max | | | | <u>+</u> 3.0 | uA |
| I _{LIT} | A9 Input Load Current | Vcc=Vcc max; A9=12. | .5V | | | 35 | uA |
| I _{LR} | RESET# Input Load Current | Vcc=Vcc max; RESET#= | 12.5V | | | 35 | uA |
| I _{LO} | Output Leakage Current | Vout=Vss to Vcc, Vcc=Vcc max | | | | <u>+</u> 1.0 | uA |
| | | | 5MHz | | 10 | 16 | mA |
| I _{CCI} | Vcc Active Read Current | CE#=V _{IL} OE#=V _{IH} , Byte mode | 1MHz | | 2 | 4 | |
| | (Notes 1,2) | CE#=V _{IL} , OE#=V _{IH} , Word | 5MHz | | 10 | 16 | |
| | | mode | 1MHz | | 2 | 4 | |
| I _{CC2} | Vcc Active Write Current (Note 2,3) | CE#=V _{IL} , OE#=V _{IH} , WE | | 15 | 30 | mA | |
| I _{CC3} | Vcc Standby Current (Note 2) | by Current (Note 2) CE#, RESET#= Vcc±0.3V | | | 0.2 | 5 | uA |
| I _{CC4} | Vcc Reset Current (Note 2) | RESET#=Vss ± 0.3V | | | 0.2 | 5 | uA |
| I _{CC5} | Automatic Sleep Mode (Notes2,4) | $V_{IH} = Vcc \pm 0.3V$ $V_{IL} = Vss \pm 0.3V$ | | | 0.2 | 5 | uA |
| V _{IL} | Input Low Voltage | | | -0.5 | | 0.8 | V |
| V _{IH} | Input High Voltage | | | 0.7xVcc | | Vcc+0.3 | V |
| V_{HH} | Voltage for WP#/ACC Sector Protect/Unprotect and Program Acceleration Vcc = 3.0V ± 10% | | | 11.5 | | 12.5 | ٧ |
| V_{ID} | Voltage for Autoselect and Temporary Sector Unprotect | Vcc = 3.0V <u>+</u> 10% | 11.5 | | 12.5 | V | |
| V _{OL} | Output Low Voltage I _{OL} = 4.0 mA, Vcc = Vcc min | | min | | | 0.45 | ٧ |
| V _{OH1} | Output I Pale Value | I _{OH} = -2.0mA, Vcc = Vcc | 0.85 Vcc | | | ., | |
| V _{OH2} | Output High Voltage | I _{OH} = -100 uA, Vcc = Vc | Vcc - 0.4 | | | \ | |
| V_{LKO} | Low Vcc Lock-Out Voltage (Note 5) | | | | | 2.5 | ٧ |

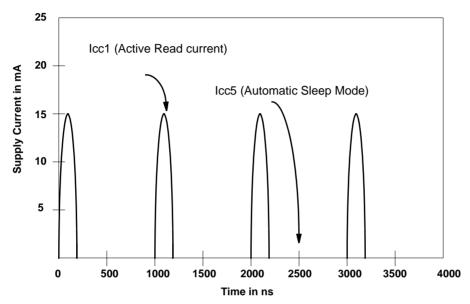
Notes:

- 1. The lcc current listed is typically less than 2 mA/MHz, with OE# at V_{IH} , Typical condition: 25°C, Vcc = 3V
- 2. Maximum I_{CC} specifications are tested with Vcc = Vcc max.
- 3. Icc active while Embedded Erase or Embedded Program is in progress.
- 4. Automatic sleep mode enables the low power mode when addresses remain stable for t_{ACC} + 30ns. Typical sleep mode current is 200 nA.
- 5. Not 100% tested.



DC CHARACTERISTICS

Zero-Power Flash



Note: Addresses are switching at 1 MHz

Figure 14. I_{cc1} Current vs. Time (Showing Active and Automatic Sleep Currents)

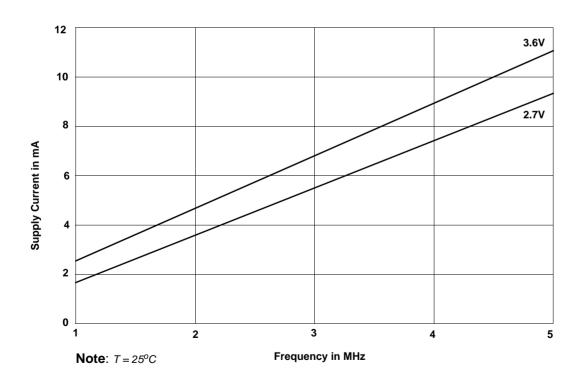


Figure 15. Typical I_{cc1} vs. Frequency



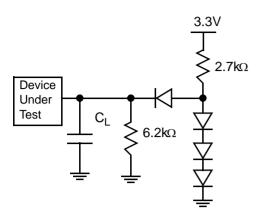


Figure 16. Test Setup

Note: Diodes are IN3064 or equivalent

Table 12. Test Specifications

| Test Condition | 80R | 90 | 120 |
|---------------------------------------------------------------------|-------|-----------|--------|
| Output Load | | 1TTL ga | te |
| Output Load Capacitance, C _L (including jig capacitance) | 30 pF | 30 pF | 100 pF |
| Input Rise and Fall Times | | 5 ns | |
| Input Pulse Levels | | 0.0 - 3.0 | V |
| Input timing measurement reference levels | 1.5 V | | |
| Output timing measurement reference levels | | 1.5 V | |

Key To Switching Waveforms

| WAVEFORM | INPUTS | INPUTS OUTPUTS | | | | |
|----------|----------------------------------------------------------|----------------------------------------------|--|--|--|--|
| | Steady | | | | | |
| | CI | nanging from H to L | | | | |
| _////// | CI | nanging from L to H | | | | |
| | Don't Care, Any Change Permitted Changing, State Unknown | | | | | |
| | Does Not Apply | Center Line is High Impedance State (High Z) | | | | |

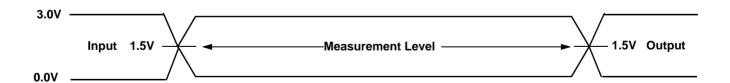


Figure 17. Input Waveforms and Measurement Levels



Table 13. Read-Only Operations

| Paramet | ter | Description | | | Speed Options | | Unit | | |
|-------------------|------------------|----------------------------------------------|-------------------------------|-------------------------|---------------|-----|------|-----|----|
| JEDEC | Std. | De | escription | Test Setup | | 80R | 90 | 120 | |
| t _{AVAV} | t _{RC} | Read Cycle Time(Note 1 |) | | Min | 80 | 90 | 120 | ns |
| t_{AVQV} | t _{ACC} | Address to Output Delay | , | CE#,OE#=V _{IL} | Max | 80 | 90 | 120 | ns |
| t _{ELQV} | t _{CE} | Chip Enable to Output D | OE#=V _{IL} | Max | 80 | 90 | 120 | ns | |
| t_{GLQV} | t _{OE} | Output Enable to Output | Output Enable to Output Delay | | | 35 | 40 | 50 | ns |
| t _{EHQZ} | t _{DF} | Chip Enable to Output H | igh Z (Note 1) | | Max | | 16 | | ns |
| t _{GHQZ} | t _{DF} | Output Enable to Output | High Z (Note 1) | | Max | | 16 | | ns |
| t _{AXQX} | t _{OH} | Output Hold Time From Whichever Occurs First | | Min | | 0 | | ns | |
| | t _{OEH} | Output Enable Hold | Read | | Min | | 0 | | ns |
| | | Time (Note 1) | Toggle and Data# Polling | | Min | | 10 | | ns |

Note: 1. Not 100% tested

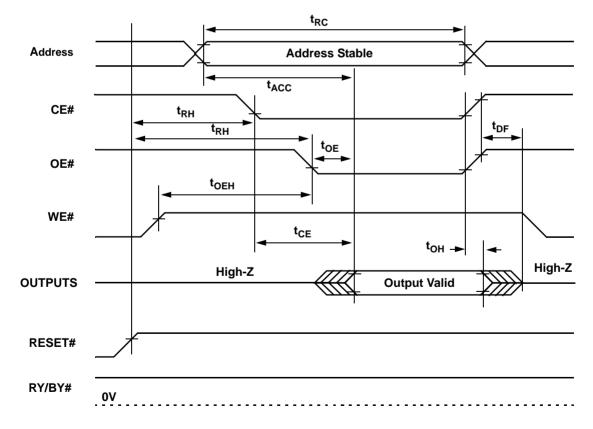


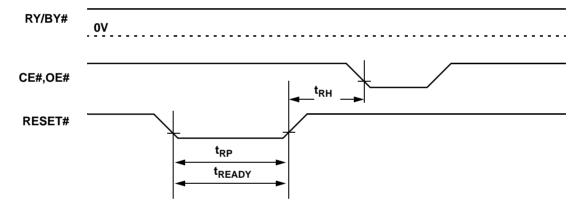
Figure 18. Read Operation Timings



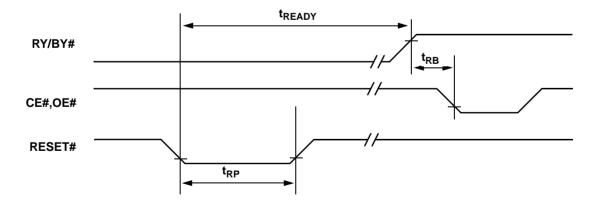
Table 14. Hardware Reset (RESET #)

| Para | ameter | | | | |
|-------|--------------------|----------------------------------------------------------------------------|-----|-------------------|------|
| JEDEC | Std. | Description | | All Speed Options | Unit |
| | t _{Ready} | RESET# Pin Low (During Embedded Algorithms) to Read Mode (See Note) | Max | 20 | us |
| | t _{Ready} | RESET# Pin Low (Not During Embedded Algorithms) to Read Mode (See Note) | | 500 | ns |
| | t _{RP} | RESET# Pulse Width | Min | 500 | ns |
| | t _{RH} | RESET High Time Before Read (See Note) | Min | 50 | ns |
| | t _{RPD} | RESET# Low to Standby Mode | Min | 20 | us |
| | t _{RB} | RY/BY# Recovery Time | Min | 0 | ns |

Note: Not 100% tested



(A) Not During Embedded Algorithm



(B) During Embedded Algorithm

Figure 19. Reset Timings



Table 15. Word/Byte Configuration (BYTE#)

| Parameter | | | | | | | |
|-----------|--------------------------------------|---------------------------------------|-----|-----|----|-----|------|
| JEDEC | Std. | Description | | 80R | 90 | 120 | Unit |
| | t _{ELFL} /t _{ELFH} | CE# to BYTE# Switching Low or High | Max | | 5 | | ns |
| | t_{FLQZ} | BYTE# Switching Low to Output HIGH Z | Max | | 30 | | ns |
| | t _{FHQV} | BYTE# Switching High to Output Active | | 80 | 90 | 120 | ns |

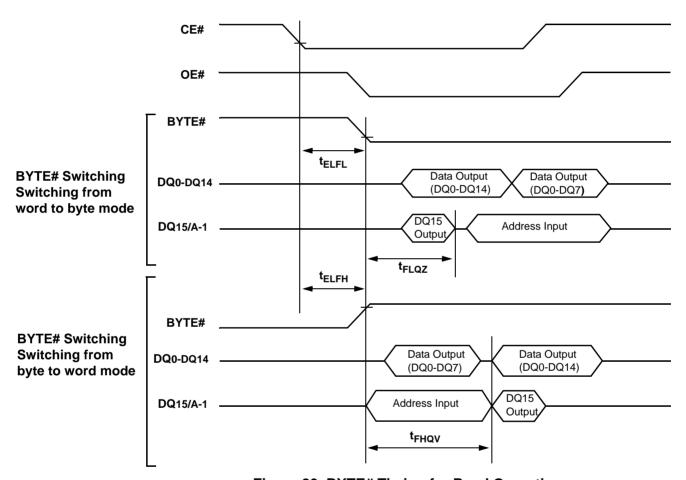
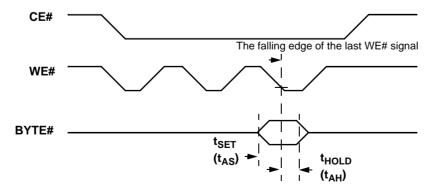


Figure 20. BYTE# Timing for Read Operations



Note : Refer to the Erase/Program Operations table for t_{AS} and t_{AH} specifications.

Figure 21. BYTE# Timing for Write Operations



Table 16. Erase and Program Operations

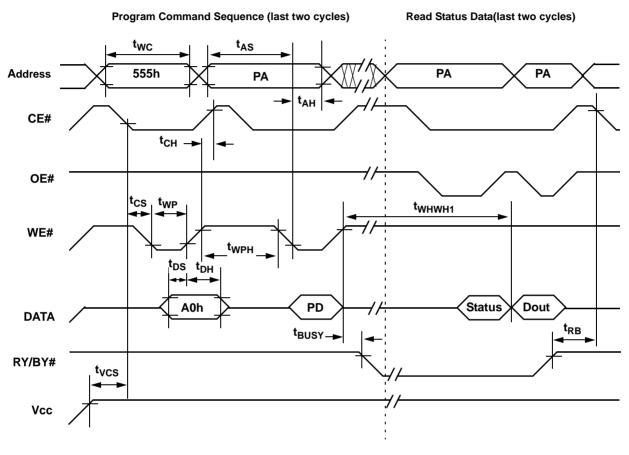
| Paramete | er | _ | | | | | | |
|--------------------|--------------------|----------------------------------|------------------------------------|-----|-----|-----|-----|------|
| JEDEC | Std. | Desci | ription | | 80R | 90 | 120 | Unit |
| t _{AVAV} | t _{WC} | Write Cycle Time (Note 1) | | Min | 80 | 90 | 120 | ns |
| t _{AVWL} | t _{AS} | Address Setup Time | | Min | | 0 | | ns |
| | t _{ASO} | Address Setup Time to OE# low de | uring toggle bit polling | Min | | 15 | | ns |
| t _{WLAX} | t _{AH} | Address Hold Time | | Min | 45 | 45 | 50 | ns |
| | t _{AHT} | Address Hold Time From CE# or C | DE# high during toggle bit polling | Min | | 0 | | ns |
| t _{DVWH} | t _{DS} | Data Setup Time | | Min | 45 | 45 | 50 | ns |
| t _{WHDX} | t _{DH} | Data Hold Time | | Min | | 0 | | ns |
| | t _{OEPH} | Output Enable High during toggle | bit polling | Min | | 20 | | ns |
| t _{GHWL} | t _{GHWL} | Read Recovery Time Before Write | (OE# High to WE# Low) | Min | 0 | | | ns |
| t _{ELWL} | t _{CS} | CE# Setup Time | | Min | 0 | | | ns |
| t _{WHEH} | t _{CH} | CE# Hold Time | | Min | | 0 | | ns |
| t _{WLWH} | t _{WP} | Write Pulse Width | | Min | 35 | 35 | 50 | ns |
| t _{WHDL} | t _{WPH} | Write Pulse Width High | | Min | | 30 | | ns |
| | t _{SR/W} | Latency Between Read and Write | Operations | Min | | 0 | | ns |
| | | | Byte | Тур | | 9 | | |
| t _{WHWH1} | t _{WHWH1} | Programming Operation (Note 2) | Word | Тур | | 11 | | us |
| t _{WHWH1} | t _{WHWH1} | Accelerated Programming Operati | on, Word or Byte (Note 2) | Тур | 8 | | | us |
| t _{WHWH2} | t _{WHWH2} | Sector Erase Operation (Note 2) | | Тур | | 0.7 | | sec |
| | t _{VCS} | Vcc Setup Time (Note 1) | | Min | | 50 | | us |
| | t _{RB} | Write Recovery Time from RY/BY# | ‡ | Min | | 0 | | ns |
| _ | t _{BUSY} | Program/Erase Valid to RY/BY# D | elay | Max | | 90 | | ns |

Notes:

^{1.} Not 100% tested.

 $^{{\}it 2. See the "Erase And Programming Performance" section for more information.}\\$

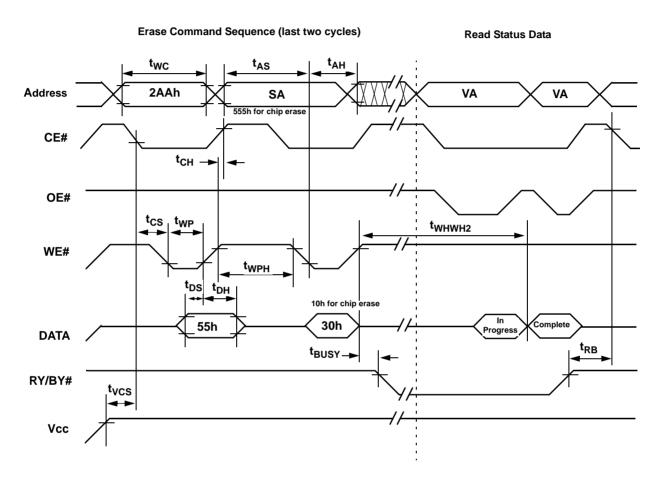




- NOTES:
- 1. PA = program address, PD = program data, Dout is the true data at the program address.
- 2. Illustration shows device in word mode.

Figure 22. Program Operation Timings



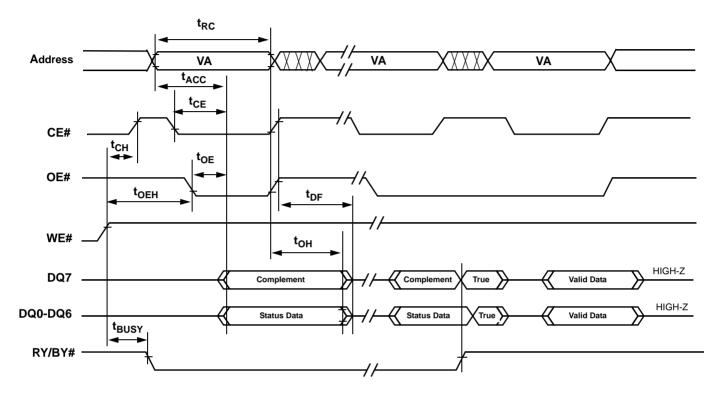


NOTES:

- 1. SA = sector address(for Sector Erase), VA = valid address for reading status data(see "Write Operation Status").
- 2. These waveforms are for the word mode.

Figure 23. Chip/Sector Erase Operation Timings

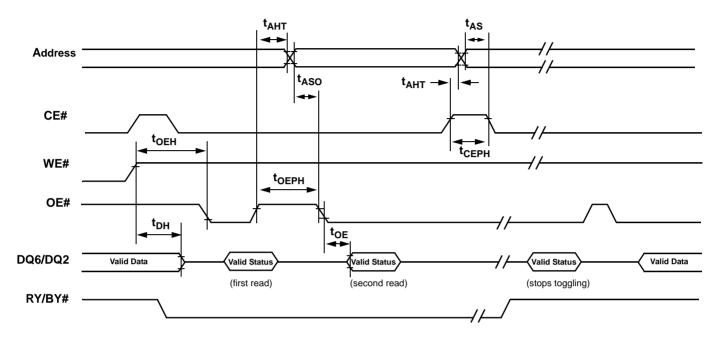




NOTE: VA = Valid address. Illustration shows first status cycle after command sequence, last status read cycle, and array data read cycle

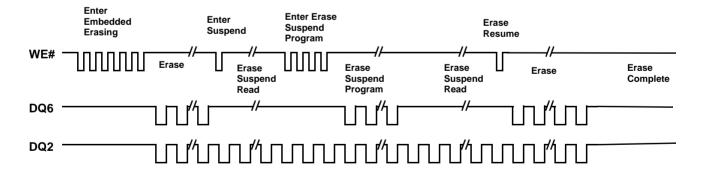
Figure 24. Data# Polling Timings (During Embedded Algorithms)





NOTE: VA = Valid address; not required for DQ6. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle.

Figure 25. Toggle Bit Timings (During Embedded Algorithms)



NOTE: DQ2 toggles only when read at an address within an erase-suspended sector. The system may use OE# or CE# to toggle DQ2 and DQ6.

Figure 26. DQ2 vs. DQ6



Table 17. Temporary Sector Unprotect

| Paramet | er | | | | |
|---------|------------------|------------------------------------------------------------------|-----|-------------------|------|
| JEDEC | Std. | Description | | All Speed Options | Unit |
| | t_{VIDR} | V _{ID} Rise and Fall Time (See Note) | Min | 500 | ns |
| | t_{VHH} | V _{HH} Rise and Fall Time (See Note) | Min | 250 | ns |
| | t _{RSP} | RESET# Setup Time for Temporary Sector Unprotect | Min | 4 | us |
| | t _{RRB} | RESET# Hold Time from RY/BY# High for Temporary Sector Unprotect | Min | 4 | us |

Note: Not 100% tested.

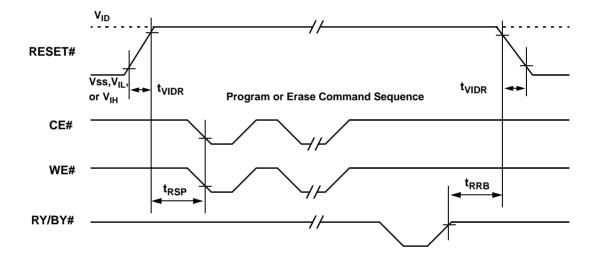


Figure 27. Temporary Sector Unprotect Timing Diagram

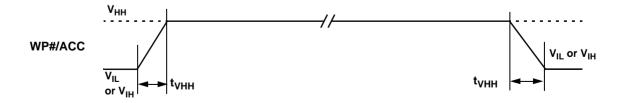
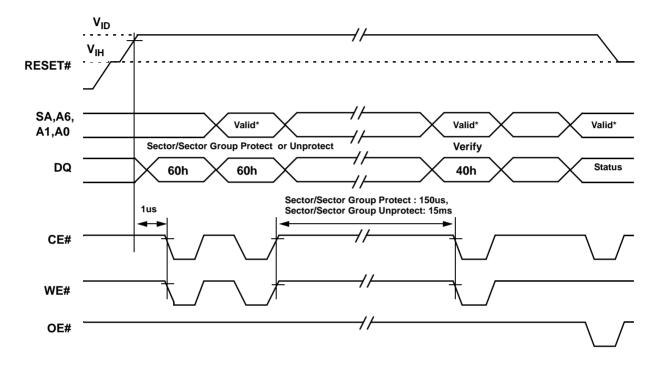


Figure 28. Accelerated Program Timing Diagram





^{*} For sector protect, A6=0,A1=1,A0=0 For sector unprotect, A6=1,A1=1,A0=0

Figure 29. Sector/Sector Group Protect & Unprotect Timing Diagram



Table 18. Alternate CE# Controlled Erase and Program Operations

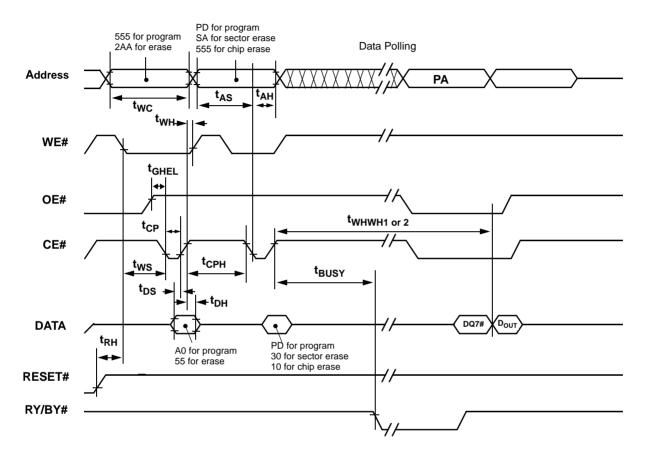
| Paramete | er | | | | 80R | 90 | | |
|--------------------|--------------------|----------------------------------------------------------|-------------------------------------------------------|-----|-----|-----|-----|------|
| JEDEC | Std. | Description | Description | | | | 120 | Unit |
| t _{AVAV} | t _{WC} | Write Cycle Time(Note 1) | | Min | 80 | 90 | 120 | ns |
| t _{AVWL} | t _{AS} | Address Setup Time | | Min | | 0 | | ns |
| t _{ELAX} | t _{AH} | Address Hold Time | | Min | 45 | 45 | 50 | ns |
| t _{DVEH} | t _{DS} | Data Setup Time | | Min | 45 | 45 | 50 | ns |
| t _{EHDX} | t _{DH} | Data Hold Time | | Min | | 0 | | ns |
| t _{GHEL} | t _{GHEL} | Read Recovery Time Before Write (OE# High | Read Recovery Time Before Write (OE# High to WE# Low) | | | 0 | | |
| t _{WLEL} | t _{WS} | WE# Setup Time | | Min | 0 | | | ns |
| t _{EHWH} | t _{WH} | WE# Hold Time | | Min | | 0 | | ns |
| t _{ELEH} | t _{CP} | CE# Pulse Width | | Min | 45 | 45 | 50 | ns |
| t _{ELEL} | t _{CPH} | CE# Pulse Width High | | Min | | 30 | | ns |
| | | | Byte | Тур | | 9 | | |
| t _{WHWH1} | t _{WHWH1} | Programming Operation (Note 2) Word | | Тур | | 11 | | us |
| t _{WHWH1} | t _{WHWH1} | Accelerated Programming Operation, Word or Byte (Note 2) | | | | 8 | | us |
| t _{WHWH2} | t _{WHWH2} | Sector Erase Operation (Note 2) | Sector Erase Operation (Note 2) | | | 0.7 | | sec |

Notes:

^{1.} Not 100% tested

^{2.} See the "Erase And Programming Performance" section for more information.





NOTES:

- 1. Figure indicates last two bus cycles of a program or erase operation.
- 2. PA = program address, SA = sector address, PD = program data
- 3. DQ7# is the complement of the data written to the device. Dout is the data written to the device.
- 4. Waveforms are for the word mode.

Figure 30. Alternate CE# Controlled
Write(Erase/Program) Operation Timings



Table 19. AC CHARACTERISTICS

| Parameter | Description | | Value | Unit |
|-------------------|----------------------------------------------|-----|----------|------|
| t _{OE} | Output Enable to Output Delay | Max | 35/40/50 | ns |
| t _{VIDR} | Voltage Transition Time | Min | 500 | ns |
| t _{WPP1} | Write Pulse Width for Protection Operation | Min | 150 | us |
| t _{WPP2} | Write Pulse Width for Unprotection Operation | Min | 15 | ms |
| t _{OESP} | OE# Setup Time to WE# Active | Min | 4 | us |
| t _{CSP} | CE# Setup Time to WE# Active | Min | 4 | us |
| t _{ST} | Voltage Setup Time | Min | 4 | us |

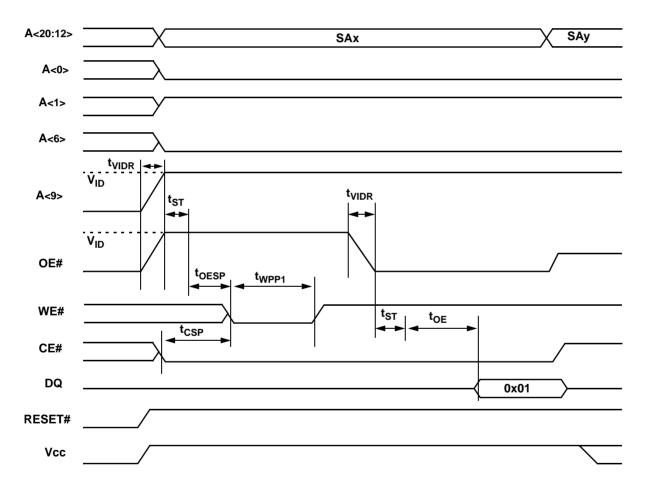
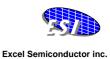
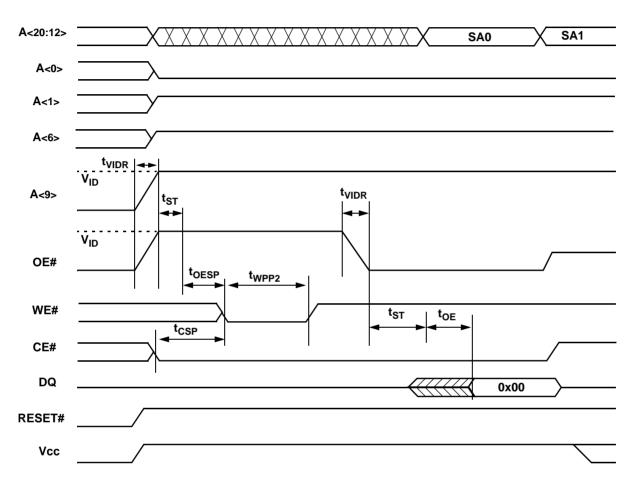


Figure 31. Sector Protection timings (A9 High-Voltage Method)





NOTE: It is recommended to verify for all sectors.

Figure 32. Sector Unprotection timings (A9 High-Voltage Method)



Table 20. ERASE AND PROGRAMMING PERFORMANCE

| Parameter | | Typ (Note 1) | Max (Note 2) | Unit | Comments |
|------------------------------|-----------|--------------|--------------|------|----------------------------------------|
| Sector Erase Time | | 0.7 | 15 | sec | Excludes 00h programming prior to |
| Chip Erase Time | | 112 | | sec | erasure (Note 4) |
| Byte Program Time | | 9 | 300 | us | |
| Accelerated Byte/Word Progra | ım Time | 8 | 210 | us | |
| Word Program Time | | 11 | 360 | us | Exclude system level overhead (Note 5) |
| | Byte Mode | 36 | 108 | | |
| Chip Program Time (Note 3) | Word Mode | 24 | 72 | sec | |

Notes:

- 1. Typical program and erase times assume the following conditions: 25°C, 3.0V Vcc, 10,000 cycles. Additionally, programming typicals assume checkerboard pattern.
- 2. Under worst case conditions of 90°C, Vcc = 2.7V, 100,000 cycles.
- 3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most bytes program faster than the maximum program times listed.
- 4. In the pre-programming step of the Embedded Erase algorithm, all bytes are programmed to 00h before erasure.
- 5. System-level overhead is the time required to execute the two-or-four-bus-cycle sequence for the program command. See Table 9 for further information on command definitions.
- 6. The device has a minimum erase and program cycle endurance of 100,000 cycles.

Table 21. LATCHUP CHARACTERISTICS

| Description | Min | Max |
|-----------------------------------------------------------------------------------------------|----------|-------------|
| Input voltage with respect to Vss on all pins except I/O pins (including A9, OE#, and RESET#) | - 1.0V | 12.5 V |
| Input voltage with respect to Vss on all I/O pins | - 1.0V | Vcc + 1.0 V |
| Vcc Current | - 100 mA | +100 mA |

Note: Includes all pins except Vcc. Test conditions: Vcc = 3.0 V, one pin at a time

Table 22. TSOP AND BGA PACKAGE CAPACITANCE

| Parameter Symbol | Parameter Description | Test Setup | | Тур | Max | Unit |
|------------------|-------------------------|----------------------|------|-----|-----|------|
| | | | TSOP | 6 | 7.5 | pF |
| C _{IN} | Input Capacitance | V _{IN} = 0 | FBGA | 4.2 | 5.0 | pF |
| _ | Output Capacitance | V _{OUT} = 0 | TSOP | 8.5 | 12 | pF |
| C _{OUT} | | | FBGA | 5.4 | 6.5 | pF |
| | Control Pin Capacitance | | TSOP | 7.5 | 9 | pF |
| C _{IN2} | | $V_{IN} = 0$ | FBGA | 3.9 | 4.7 | pF |

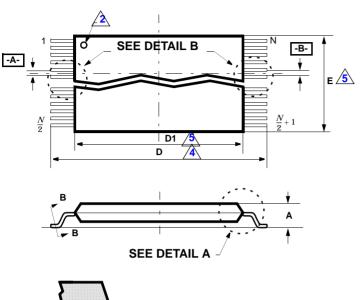
Notes:

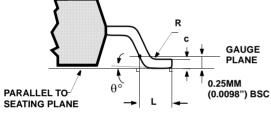
- 1. Sampled, not 100% tested
- 2. Test conditions TA = 25°C, f=1.0MHz.

Table 23. DATA RETENTION

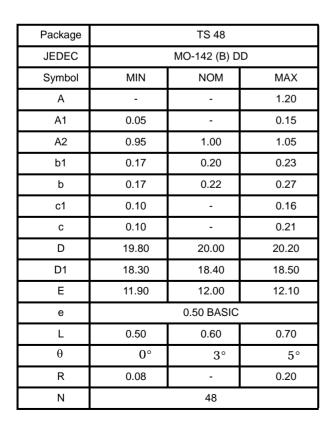
| Parameter Description | Test conditions | Min | Unit |
|-------------------------------------|-----------------|-----|-------|
| Minimum Pattern Data Retention Time | 150°C | 10 | Years |
| Millinum Fattem Data Netention Time | 125°C | 20 | Years |

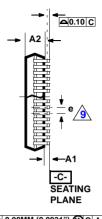
PHYSICAL DIMENSIONS 48-Pin Standard TSOP (measured in millimeters)

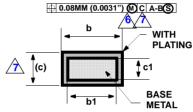




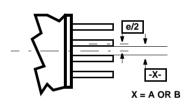
DETAIL A







SECTION B-B



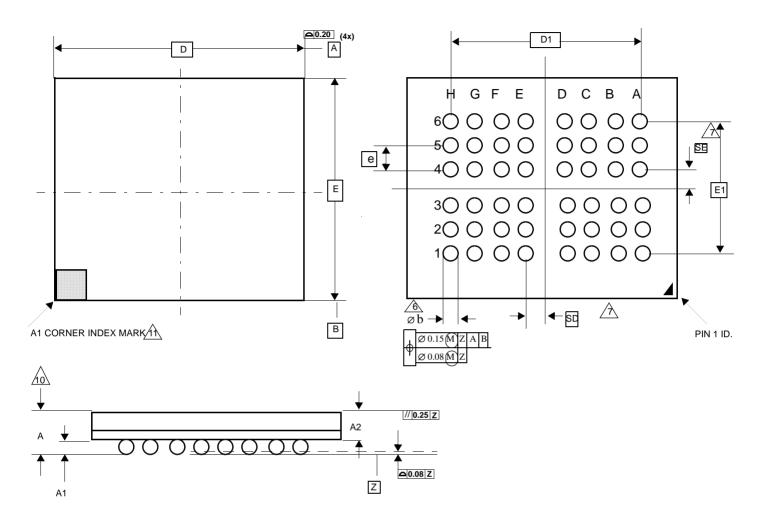
DETAIL B

NOTES:

- △ Controlling dimensions are in millimeters(mm). (Dimensioning and tolerancing conforms to ANSI Y14.5M-1982)
- **Pin 1** identifier for standard pin out (Die up).
- A Pin 1 identifier for reverse pin out (Die down): Ink or Laser mark
- To be determined at the seating plane. The seating plane is defined as the plane of contact that is made when the package leads are allowed to rest freely on a flat horizontal surface.
- <u>S</u> Dimension **D1** and **E** do not include mold protrusion. Allowable mold protrusion is 0.15mm (0.0059") per side.
- Dimension **b** does not include dambar protrusion. Allowable dambar protrusion shall be 0.08mm (0.0031") total in excess of **b** dimension at max. material condition. Minimum space between protrusion and an adjacent lead to be 0.07mm (0.0028").
- These dimensions apply to the flat section of the lead between 0.10mm (0.0039") and 0.25mm (0.0098") from the lead tip.
- 8. Lead coplanarity shall be within 0.10mm (0.004") as measured from the seating plane.
- <u>A</u> Dimension "e" is measured at the centerline of the leads.



PHYSICAL DIMENSIONS 48-Ball FBGA (8 x 9 mm)



| PACKAGE | | xFB | 3D 048 | |
|---------|---------------------------|------|--------|----------------------------|
| JEDEC | | 1 | V/A | |
| | 8.00 mm x 9.00 mm PACKAGE | | | |
| SYMBOL | MIN | NOM | MAX | NOTE |
| А | | | 1.20 | OVERALL THICK NESS |
| A1 | 0.20 | | | BALL HEIGHT |
| A2 | 0.84 | | 0.94 | BODY THICKNESS |
| D | | 9.00 | BSC | BODY SIZE |
| E | | 8.00 | 0 BSC | BODY SIZE |
| D1 | | 5.60 | 0 BSC | BALL FOOTPRINT |
| E1 | | 4.00 | 0 BSC | BALL FOOTPRINT |
| MD | 8 | | | ROW MATRIX SIZED DIRECTION |
| ME | 6 | | | ROW MATRIX SIZED DIRECTION |
| N | 48 | | | TOTAL BALL COUNT |
| b | 0.25 | 0.30 | 0.35 | BALL DIAMETER |
| е | | 0.80 | 0 BSC | BALL PITCH |
| SD / SE | 0.40 BSC | | | SOLDER BALL PLACEMENT |

NOTES:

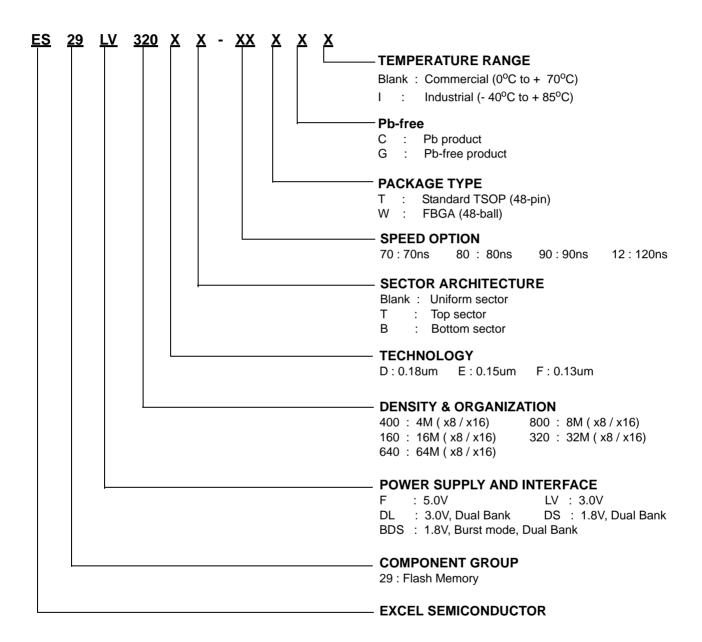
- 1. Dimensioning and tolerancing per ASME Y14.5M-1994
- 2. All dimensions are in millimeters.
- 3. Ball position designation per JESD 95-1, SPP-010.
- 4. e represents the solder ball grid pitch.
- Symbol "MD" is the ball row matrix size in the "D" direction. Symbol "ME" is the ball column matrix size in the "E" direction. N is the maximum number of solder balls for matrix size MD X ME.
- /ô Dimension "b" is measured at the maximum ball diameter in a plane parallel to datum **Z**.
- SD and SE are measured with respect to datums A and B and define the position of the center solder ball in the outer row. When there is an odd number of solder balls in the outer row parallel to the D or E dimension, respectively, SD or SE = 0.000 when there is an even number of solder balls in the outer row, SD or SE = e/2
- 8. "X" in the package variations denotes part is outer qualification.
- "+" in the package drawing indicate the theoretical center of depopulated balls.
- And For package thickness A is the controlling dimension.
- A1 corner to be indentified by chamfer, ink mark, metallized markings indention or other means.



ORDERNG INFORMATION

Standard Products

ESI standard products are available in several package and operating ranges. The order number (Valid Combination) is formed by a combination of the following:





Product Selection Guide

Industrial Device

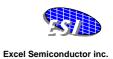
| Part No. | Speed | Vcc | Boot Sector | Package | Pb | Ball Pitch/Size | Body Size |
|--------------------|-------|------------|-------------|--------------|---------|-----------------|-----------|
| ES29LV320DT-80RTGI | 80ns | 3.0 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-80RTCI | 80ns | 3.0 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-80RTGI | 80ns | 3.0 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-80RTCI | 80ns | 3.0 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-90TGI | 90ns | 2.7 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-90TCI | 90ns | 2.7 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-90TGI | 90ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-90TCI | 90ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-12TGI | 120ns | 2.7 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-12TCI | 120ns | 2.7 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-12TGI | 120ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-12TCI | 120ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-80RWGI | 80ns | 3.0 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-80RWCI | 80ns | 3.0 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-80RWGI | 80ns | 3.0 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-80RWCI | 80ns | 3.0 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-90WGI | 90ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-90WCI | 90ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-90WGI | 90ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-90WCI | 90ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-12WGI | 120ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-12WCI | 120ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-12WGI | 120ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-12WCI | 120ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |



Product Selection Guide

Commercial Device

| Part No. | Speed | Vcc | Boot Sector | Package | Pb | Ball Pitch/Size | Body Size |
|-------------------|-------|------------|-------------|--------------|---------|-----------------|-----------|
| ES29LV320DT-80RTG | 80ns | 3.0 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-80RTC | 80ns | 3.0 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-80RTG | 80ns | 3.0 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-80RTC | 80ns | 3.0 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-90TG | 90ns | 2.7 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-90TC | 90ns | 2.7 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-90TG | 90ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-90TC | 90ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-12TG | 120ns | 2.7 - 3.6V | Тор | 48-pin TSOP | Pb-free | | |
| ES29LV320DT-12TC | 120ns | 2.7 - 3.6V | Тор | 48-pin TSOP | - | | |
| ES29LV320DB-12TG | 120ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | Pb-free | | |
| ES29LV320DB-12TC | 120ns | 2.7 - 3.6V | Bottom | 48-pin TSOP | - | | |
| ES29LV320DT-80RWG | 80ns | 3.0 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-80RWC | 80ns | 3.0 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-80RWG | 80ns | 3.0 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-80RWC | 80ns | 3.0 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-90WG | 90ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-90WC | 90ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-90WG | 90ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-90WC | 90ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-12WG | 120ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DT-12WC | 120ns | 2.7 - 3.6V | Тор | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-12WG | 120ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | Pb-free | 0.8mm/0.3mm | 8mm x 9mm |
| ES29LV320DB-12WC | 120ns | 2.7 - 3.6V | Bottom | 48-Ball FBGA | - | 0.8mm/0.3mm | 8mm x 9mm |



Document Title

32M Flash Memory

Revision History

| Revision Number | Data | Items |
|-----------------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Rev. 0A | Nov. 10, 2003 | Initial Release Version. |
| Rev. 0B | Nov. 26, 2003 | The typical program/erase current value changed from 30mA to 15mA. The Table 6 for manufacture ID is changed to 4Ah. The extended temperature range is removed and the commercial temperature range is added. |
| Rev. 0C | Feb. 4, 2004 | 1. E/W cycle number is changed from 1,000,000 to 100,000. 2. CFI code is changed : 45h : 04h> 45h : 00h |
| Rev. 1A | Mar. 1, 2004 | The format of datasheet is entirely changed and updated 70ns product is removed 80R product (80ns : Vcc = 3.0 ~ 3.6V) is newly added. A command diagram is added. Sector protection / unprotection algorithm by A9 high-voltage method is described. A limitation to the maximum number of E/W cycles in the Security Sector is described (300 E/W cycles at Max.). A product selection table is added. Test condtions for the typical performance of program/erase : after 100,000 E/W cycles> after 10,000 E/W cycles |
| Rev. 1B | Apr. 23, 2004 | The bias condition of RESET# in Table 1 for A9 high-Voltage is changed from V_{ID} to H. The bias condition of A9 in Table 1 for A9 high-Voltage method is added. |

The attached datasheets are provided by Excel Semiconductor.inc (ESI). ESI reserves the right to change the specifications and products. ESI will answer to your questions about device. If you have any questions, please contact the ESI office.